

# RADIO TEST REPORT

## Test Report No. 15375714H-C-R1

Customer	Nintendo Co., Ltd.
Description of EUT	Wireless device
Model Number of EUT	CLO-001
FCC ID	BKECLO001
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	September 5, 2024
Remarks	Wireless LAN (2.4 GHz band) part

Representative Test Engineer



Junya Okuno  
Engineer

Approved By



Ryota Yamanaka  
Engineer



CERTIFICATE 5107.02

- The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.  
 There is no testing item of "Non-accreditation".

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 23.0

## **ANNOUNCEMENT**

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- The results in this report apply only to the sample tested. (Laboratory was not involved in sampling.)
- This sample tested is in compliance with the limits of the above regulation.
- The test results in this test report are traceable to the national or international standards.
- This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
- This test report covers Radio technical requirements.  
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan, Inc. has been accredited.
- The information provided by the customer for this report is identified in SECTION 1.
- The laboratory is not responsible for information provided by the customer which can impact the validity of the results.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

## **REVISION HISTORY**

### **Original Test Report No.: 15375714H-C**

This report is a revised version of 15197671H-C. 15197671H-C is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15375714H-C	August 23, 2024	-
1	15375714H-C-R1	September 5, 2024	- Correction of the Antenna Gain for Conducted Spurious Emission data; From "3.9" to "3.85" - In accordance with the above, correction of the notation of other values.

**Reference: Abbreviations (Including words undescribed in this report)**

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	IEC	International Electrotechnical Commission
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers
AM	Amplitude Modulation	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISO	International Organization for Standardization
AP	Access Point	JAB	Japan Accreditation Board
ASK	Amplitude Shift Keying	LAN	Local Area Network
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System
AV	Average	MCS	Modulation and Coding Scheme
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement
BR	Bluetooth Basic Rate	N/A	Not Applicable
BT	Bluetooth	NIST	National Institute of Standards and Technology
BT LE	Bluetooth Low Energy	NS	No signal detect.
BW	BandWidth	NSA	Normalized Site Attenuation
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program
CCK	Complementary Code Keying	OBW	Occupied Band Width
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width
EN	European Norm	RDS	Radio Data System
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment
EU	European Union	RF	Radio Frequency
EUT	Equipment Under Test	RMS	Root Mean Square
Fac.	Factor	RSS	Radio Standards Specifications
FCC	Federal Communications Commission	Rx	Receiving
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer
FM	Frequency Modulation	SG	Signal Generator
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio
FSK	Frequency Shift Keying	TR	Test Receiver
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting
GNSS	Global Navigation Satellite System	VBW	Video BandWidth
GPS	Global Positioning System	Vert.	Vertical
Hori.	Horizontal	WLAN	Wireless LAN

---

<b>CONTENTS</b>	<b>PAGE</b>
<b>SECTION 1: Customer Information .....</b>	<b>5</b>
<b>SECTION 2: Equipment Under Test (EUT).....</b>	<b>5</b>
<b>SECTION 3: Test Specification, Procedures &amp; Results .....</b>	<b>7</b>
<b>SECTION 4: Operation of EUT during testing .....</b>	<b>10</b>
<b>SECTION 5: Conducted Emission.....</b>	<b>13</b>
<b>SECTION 6: Radiated Spurious Emission.....</b>	<b>14</b>
<b>SECTION 7: Antenna Terminal Conducted Tests .....</b>	<b>16</b>
<b>APPENDIX 1: Test Data .....</b>	<b>17</b>
Conducted Emission .....	17
99 % Occupied Bandwidth and 6 dB Bandwidth.....	18
Maximum Peak Output Power .....	25
Radiated Spurious Emission.....	29
Conducted Spurious Emission.....	48
Power Density .....	49
<b>APPENDIX 2: Test Instruments .....</b>	<b>53</b>
<b>APPENDIX 3: Photographs of Test Setup .....</b>	<b>55</b>
Conducted Emission .....	55
Radiated Spurious Emission.....	56
Worst Case Position .....	57
Antenna Terminal Conducted Tests .....	58

## **SECTION 1: Customer Information**

Company Name	Nintendo Co., Ltd.
Address	11-1 Hokotate-cho, Kamitoba, Minami-ku, Kyoto 601-8501, Japan
Telephone Number	+81-75-662-9600
Contact Person	Hideki Ohashi

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

## **SECTION 2: Equipment Under Test (EUT)**

### **2.1 Identification of EUT**

Description	Wireless device
Model Number	CLO-001
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	February 21, 2024
Test Date	March 4 and 5, 2024

### **2.2 Product Description**

#### **General Specification**

Rating	DC 5 V
Operating temperature	5 deg. C to 35 deg. C

---

## **Radio Specification**

This report contains data provided by the customer which can impact the validity of results. UL Japan, Inc. is only responsible for the validity of results after the integration of the data provided by the customer. The data provided by the customer is marked "a)" in the table below.

### **WLAN (IEEE802.11b/11g/11n-20)**

Equipment Type	Transceiver
Frequency of Operation	2412 MHz to 2472 MHz
Type of Modulation	DSSS, OFDM
Antenna Type	Inverted F Antenna
Antenna Gain <sup>a)</sup>	3.85 dBi
Receiver Category	1

### **24 GHz Sensor**

Equipment Type	Transceiver
Frequency of Operation	24.150 GHz
Frequency range	24.059 GHz to 24.239 GHz
Modulation	FMCW
Antenna type	Patch Antenna
Antenna Gain	3.5 dBi
Steerable Antenna	None
Usage location	Fixed use
Receiver Category	1

## SECTION 3: Test Specification, Procedures & Results

### 3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

\* Also the EUT complies with FCC Part 15 Subpart B.

### 3.2 Procedures and Results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods ISED: RSS-Gen 8.8	FCC: Section 15.207 ISED: RSS-Gen 8.8	25.53 dB, 0.15624 MHz, QP, Phase N	Complied	-
6dB Bandwidth	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section 15.247(a)(2) ISED: RSS-247 5.2(a)	See data.	Complied	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.12	FCC: Section 15.247(b)(3) ISED: RSS-247 5.4(d)		Complied	Conducted
Power Density	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section 15.247(e) ISED: RSS-247 5.2(b)		Complied	Conducted
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.13	FCC: Section 15.247(d) ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	1.8 dB 2483.5 MHz, Vertical, AV	Complied	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *1)
Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593. * In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.  *1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 15.247 Meas Guidance v05r02 8.5 and 8.6.					

#### **FCC Part 15.31 (e)**

This EUT provides stable voltage constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

### 3.3 Addition to Standard

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
99% Occupied Bandwidth	ISED: RSS-Gen 6.7	ISED: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement. Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor  $k = 2$ .

#### Conducted emission

Item	Frequency range	Unit	Calculated Uncertainty (+/-)
AMN (LISN)	0.009 MHz to 0.15 MHz	dB	3.7
	0.15 MHz to 30 MHz	dB	3.3

#### Radiated emission

Measurement distance	Frequency range	Unit	Calculated Uncertainty (+/-)
3 m	9 kHz to 30 MHz	dB	3.3
10 m		dB	3.1
3 m	30 MHz to 200 MHz	Horizontal	4.8
		Vertical	5.0
	200 MHz to 1000 MHz	Horizontal	5.1
		Vertical	6.2
10 m	30 MHz to 200 MHz	Horizontal	4.8
		Vertical	4.8
	200 MHz to 1000 MHz	Horizontal	4.9
		Vertical	5.0
3 m	1 GHz to 6 GHz	Test Receiver	5.1
		Spectrum Analyzer	4.9
	6 GHz to 18 GHz	Test Receiver	5.4
		Spectrum Analyzer	5.2
1 m	10 GHz to 18 GHz	Spectrum analyzer	5.0
	18 GHz to 26.5 GHz	Spectrum analyzer	5.6
	26.5 GHz to 40 GHz	Spectrum analyzer	4.9
0.5 m	26.5 GHz to 40 GHz	Spectrum analyzer	4.9
10 m	1 GHz to 18 GHz	Test Receiver	5.4

#### Antenna Terminal Conducted

Item	Unit	Calculated Uncertainty (+/-)
Antenna terminated conducted emission / Power density / Burst power	dB	3.47
Adjacent channel power (ACP)	dB	2.28
Bandwidth (OBW)	%	0.96
Time readout (time span upto 100 msec)	%	0.11
Time readout (time span upto 1000 msec)	%	0.11
Time readout (time span upto 60 sec)	%	0.02
Power measurement (Power meter < 8 GHz)	dB	1.46
Power measurement (Call box < 6 GHz)	dB	1.69
Frequency readout (Frequency counter)	ppm	0.67
Frequency readout (Spectrum analyzer frequency readout function)	ppm	2.13
Temperature (constant temperature bath)	deg. C	0.69
Humidity (constant temperature bath)	%RH	2.98
Modulation characteristics	%	6.93
Frequency for mobile	ppm	0.08
Contention-based protocol	dB	2.26



### 3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

\* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 3.0 m for No.1, No.2, No.3, No.4, and No.5 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test Data, Test Instruments, and Test Set Up

Refer to APPENDIX.

## SECTION 4: Operation of EUT during testing

### 4.1 Operating Mode(s)

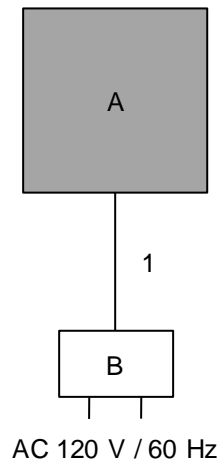
Mode	Remarks*
IEEE 802.11b (11b)	1 Mbps, PN9
IEEE 802.11g (11g)	18 Mbps, PN9
IEEE 802.11n 20 MHz BW (11n-20)	MCS 1 (Long GI), PN9
*The worst condition was determined based on the test result of Maximum Peak Output Power (Mid Channel)	
*Power of the EUT was set by the software as follows; Power Setting: 2412 MHz to 2462 MHz (1 to 11 ch): 10 [dBm] 2467 MHz (12 ch): 6 [dBm] 2472 MHz (13 ch): 4 [dBm]  Software: WLAN Test Version: X4 (Date: 2024.02.21, Storage location: EUT memory)	
*This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	
Test operating mode was determined as follows according to "Section 1 of 6 802.11 a/b/g/n testing - Managing Complex Regulatory Approvals - " of TCB Council Workshop October 2009.	

\*The Details of Operating Mode(s)

Test Item	Operating Mode	Tested Frequency
Conducted Emission, Radiated Spurious Emission (Below 1 GHz), Conducted Spurious Emission	Tx 11n-20 *1)	2412 MHz
99% Occupied Bandwidth, 6dB Bandwidth, Maximum Peak Output Power, Power Density	Tx 11b Tx 11g Tx 11n-20	2412 MHz 2437 MHz 2462 MHz 2467 MHz 2472 MHz
Radiated Spurious Emission (Above 1 GHz)	Tx 11b Tx 11n-20 *2)	2412 MHz 2437 MHz 2462 MHz 2467 MHz *3) 2472 MHz *3)
*1) The mode was tested as a representative, because it had the highest power at antenna terminal test. *2) Since 11g and 11n-20 have the same modulation method and no differences in transmitting specification, test was performed on the representative mode that had the highest peak output power. *3) The test was performed only band-edge.		

## 4.2 Configuration and Peripherals

### Conducted Emission and Radiated Emission tests



\* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

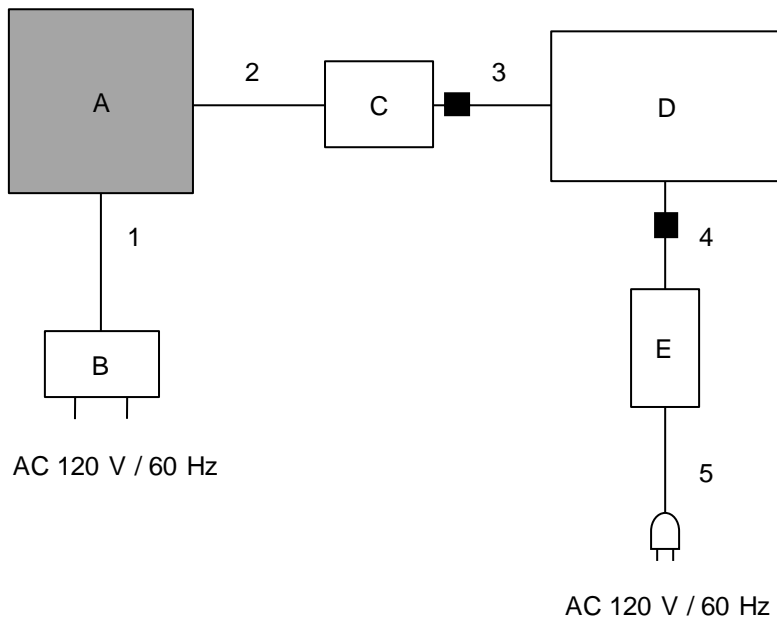
#### Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Wireless device	CLO-001	S-1657	Nintendo Co., Ltd.	EUT
B	AC Adapter	HAC-002	S-992	Nintendo Co., Ltd.	-

#### List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.5	Shielded	Shielded	Part of Item B

**Antenna Terminal Conducted test**



■ : Standard Ferrite Core

\* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

**Description of EUT and Support Equipment**

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Wireless device	CLO-001	S-1658	Nintendo Co., Ltd.	EUT
B	AC Adapter	HAC-002	S-1461	Nintendo Co., Ltd.	-
C	Debug Board	SHR-DEBUG-X1	-	Nintendo Co., Ltd.	-
D	Laptop PC	CFSV9-2	0JKSC40298	Panasonic Corporation	-
E	AC Adapter	CF-AA65D2A M1	65D2AM1223010285WA	Panasonic Corporation	-

**List of Cables Used**

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.5	Shielded	Shielded	Part of Item B
2	Flat Cable	0.3	Unshielded	Unshielded	-
3	USB Cable	1.0	Shielded	Shielded	-
4	DC Cable	1.0	Unshielded	Unshielded	-
5	AC Cable	0.8	Unshielded	Unshielded	-

## **SECTION 5: Conducted Emission**

### **Test Procedure and Conditions**

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

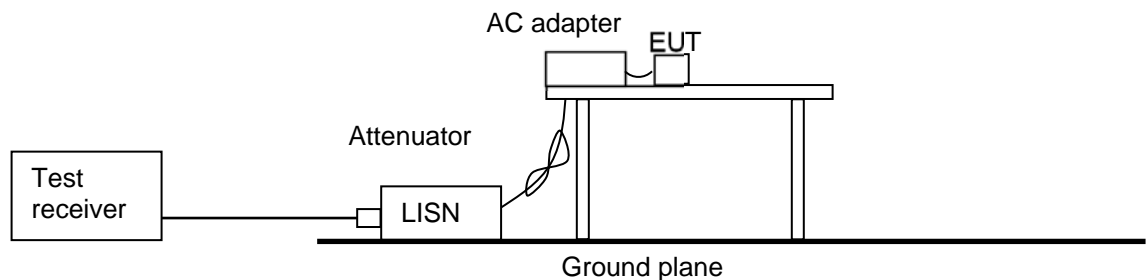
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Test results are rounded off and limit are rounded down, so some differences might be observed.

<b>Detector</b>	<b>: QP and CISPR AV</b>
<b>Measurement Range</b>	<b>: 0.15 MHz to 30 MHz</b>
<b>Test Data</b>	<b>: APPENDIX</b>
<b>Test Result</b>	<b>: Pass</b>

**Figure 1: Test Setup**



## **SECTION 6: Radiated Spurious Emission**

### **Test Procedure**

It was measured based on "8.5 and 8.6 of KDB 558074 D01 15.247 Meas Guidance v05r02".

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane. Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

### **Test Antennas are used as below;**

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

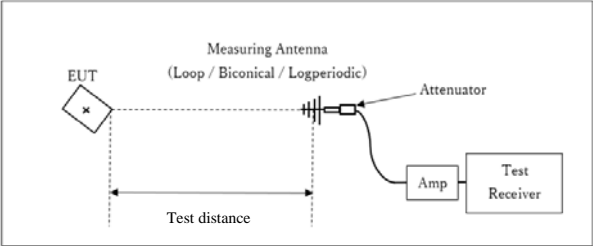
In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

### **20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).**

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument Used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	11.12.2.5.1 RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces 11.12.2.5.2 The duty cycle was less than 98% for detected noise, a duty factor was added to the 11.12.2.5.1 results.	RBW: 100 kHz VBW: 300 kHz

**Figure 2: Test Setup**

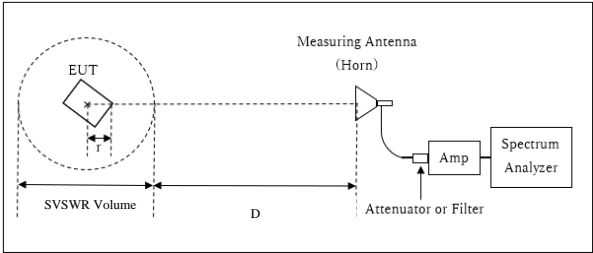
Below 1 GHz



\* : Center of turn table

Test Distance: 3 m

1 GHz to 10 GHz



r : Radius of an outer periphery of EUT  
 \* : Center of turn table

**1 GHz to 6 GHz**

Distance Factor:  $20 \times \log(3.95 \text{ m} / 3.0 \text{ m}) = 2.4 \text{ dB}$   
 \* Test Distance:  $(D + \text{SVSWR Volume} / 2) - r = 3.95 \text{ m}$

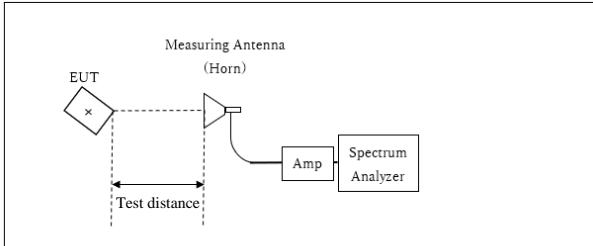
SVSWR Volume : 2.0 m  
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)  
 r = 0.05 m  
 D = 3.0 m

**6 GHz to 10 GHz**

Distance Factor:  $20 \times \log(4.95 \text{ m} / 3.0 \text{ m}) = 4.4 \text{ dB}$   
 \* Test Distance:  $(D + \text{SVSWR Volume} / 2) - r = 4.95 \text{ m}$

SVSWR Volume : 1.4 m  
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)  
 r = 0.05 m  
 D = 4.3 m

10 GHz to 26.5 GHz



\* : Center of turn table

Distance Factor:  $20 \times \log(1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$   
 \*Test Distance: 1 m

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test results are rounded off and limit are rounded down, so some differences might be observed.

**Measurement Range** : 30 MHz to 26.5 GHz  
**Test Data** : APPENDIX  
**Test Result** : Pass

## SECTION 7: Antenna Terminal Conducted Tests

### Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument Used
6dB Bandwidth	20 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	10 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *2)
Conducted Spurious Emission *3) *4)	9 kHz to 150 kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150 kHz to 30 MHz	10 kHz	30 kHz				

\*1) Peak hold was applied as Worst-case measurement.

\*2) Section 11.10.2 Method PKPSD (peak PSD) of "ANSI C63.10-2013".

\*3) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.

(9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz)

\*4) The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency 9 kHz resulted in a level of 45.5 dBuV/m, which is equivalent to  $45.5 - 51.5 = -6.0$  dBuA/m, which has the same margin, 3 dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

Test results are rounded off and limit are rounded down, so some differences might be observed.  
The equipment and cables were not used for factor 0 dB of the data sheets.

**Test Data** : APPENDIX  
**Test Result** : Pass

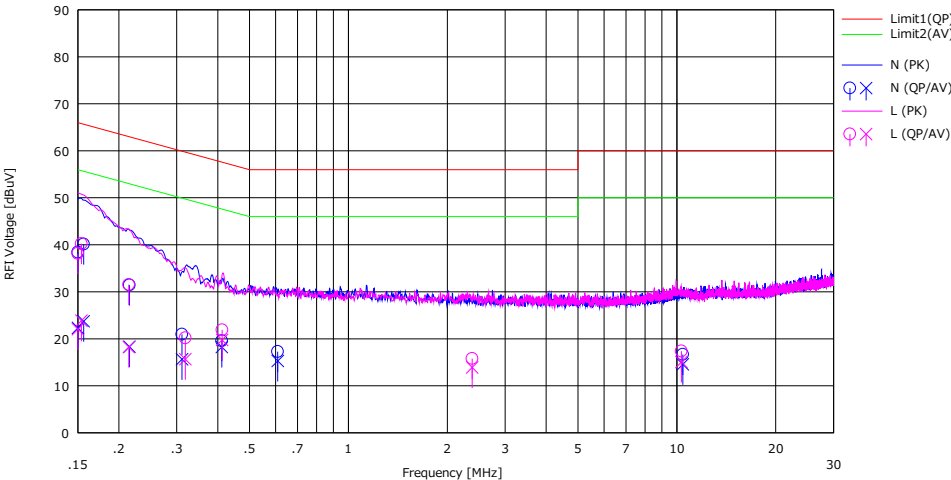


**APPENDIX 1: Test Data**

**Conducted Emission**

Test place Ise EMC Lab. No.4 Semi Anechoic Chamber  
 Date March 5, 2024  
 Temperature / Humidity 20 deg. C / 39 % RH  
 Engineer Yuichiro Yamazaki  
 Mode Tx 11n-20 2412 MHz

Limit : FCC\_Part 15 Subpart C(15.207)



No.	Freq. [MHz]	Reading		LISN [dB]	LOSS [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]			<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.15000	25.10	9.00	0.15	13.18	38.43	22.33	66.00	56.00	27.57	33.67	N	
2	0.15624	26.80	10.40	0.15	13.18	40.13	23.73	65.66	55.66	25.53	31.93	N	
3	0.21545	18.10	5.00	0.14	13.18	31.42	18.32	62.99	52.99	31.57	34.67	N	
4	0.31145	7.60	2.30	0.14	13.20	20.94	15.64	59.93	49.93	38.99	34.29	N	
5	0.41149	6.20	4.90	0.15	13.21	19.56	18.26	57.62	47.62	38.06	29.36	N	
6	0.60928	3.90	1.90	0.15	13.23	17.28	15.28	56.00	46.00	38.72	30.72	N	
7	10.42261	2.20	0.10	0.82	13.65	16.67	14.57	60.00	50.00	43.33	35.43	N	
8	0.15000	24.80	8.70	0.16	13.18	38.14	22.04	66.00	56.00	27.86	33.96	L	
9	0.15381	26.90	10.50	0.16	13.18	40.24	23.84	65.79	55.79	25.55	31.95	L	
10	0.21451	18.20	4.90	0.15	13.18	31.53	18.23	63.03	53.03	31.50	34.80	L	
11	0.31861	6.80	2.30	0.16	13.20	20.16	15.66	59.74	49.74	39.58	34.08	L	
12	0.41233	8.50	6.40	0.17	13.21	21.88	19.78	57.60	47.60	35.72	27.82	L	
13	2.38227	2.20	0.30	0.25	13.35	15.80	13.90	56.00	46.00	40.20	32.10	L	
14	10.32970	2.90	0.60	0.83	13.65	17.38	15.08	60.00	50.00	42.62	34.92	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + LISN + LOSS (CABLE + ATT)  
 Except for the above table: adequate margin data below the limits.

**99 % Occupied Bandwidth and 6 dB Bandwidth**

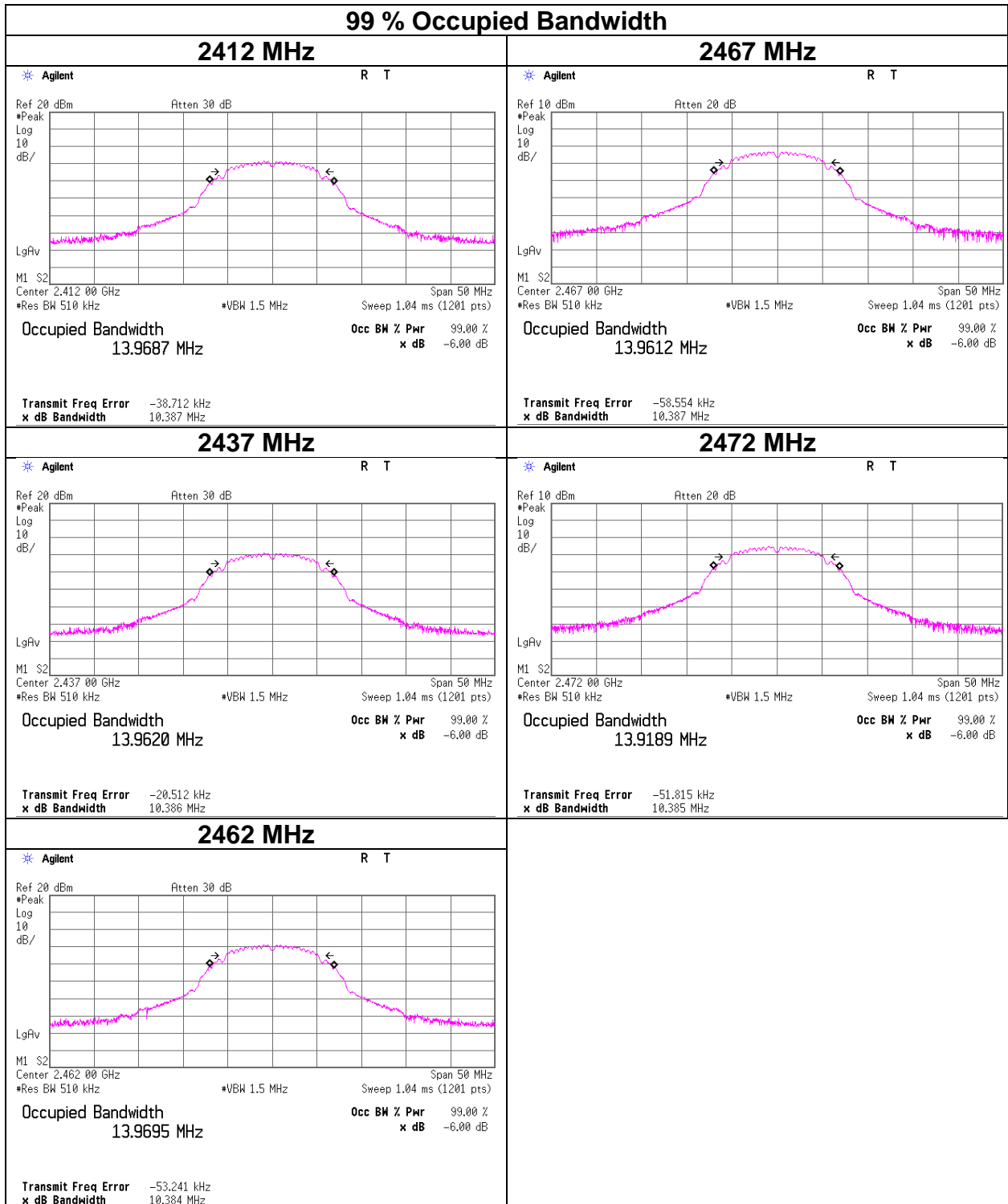
Test place                    Ise EMC Lab. No.1 Measurement Room  
Date                            March 4, 2024  
Temperature / Humidity    22 deg. C / 38 % RH  
Engineer                     Junya Okuno  
Mode                            Tx

Mode	Frequency [MHz]	99% Occupied Bandwidth [kHz]	6dB Bandwidth [MHz]	Limit for 6dB Bandwidth [MHz]
11b	2412	13968.7	10.065	> 0.5000
	2437	13962.0	10.084	> 0.5000
	2462	<b>13969.5</b>	10.097	> 0.5000
	2467	13961.2	10.097	> 0.5000
	2472	13918.9	10.092	> 0.5000
11g	2412	17072.8	16.467	> 0.5000
	2437	<b>17074.6</b>	16.459	> 0.5000
	2462	17055.9	16.460	> 0.5000
	2467	17021.6	16.463	> 0.5000
	2472	17058.6	16.461	> 0.5000
11n-20	2412	18126.4	17.702	> 0.5000
	2437	18115.4	17.689	> 0.5000
	2462	18124.2	17.699	> 0.5000
	2467	<b>18131.6</b>	17.688	> 0.5000
	2472	18114.9	17.704	> 0.5000

**99 % Occupied Bandwidth and 6 dB Bandwidth**

11b

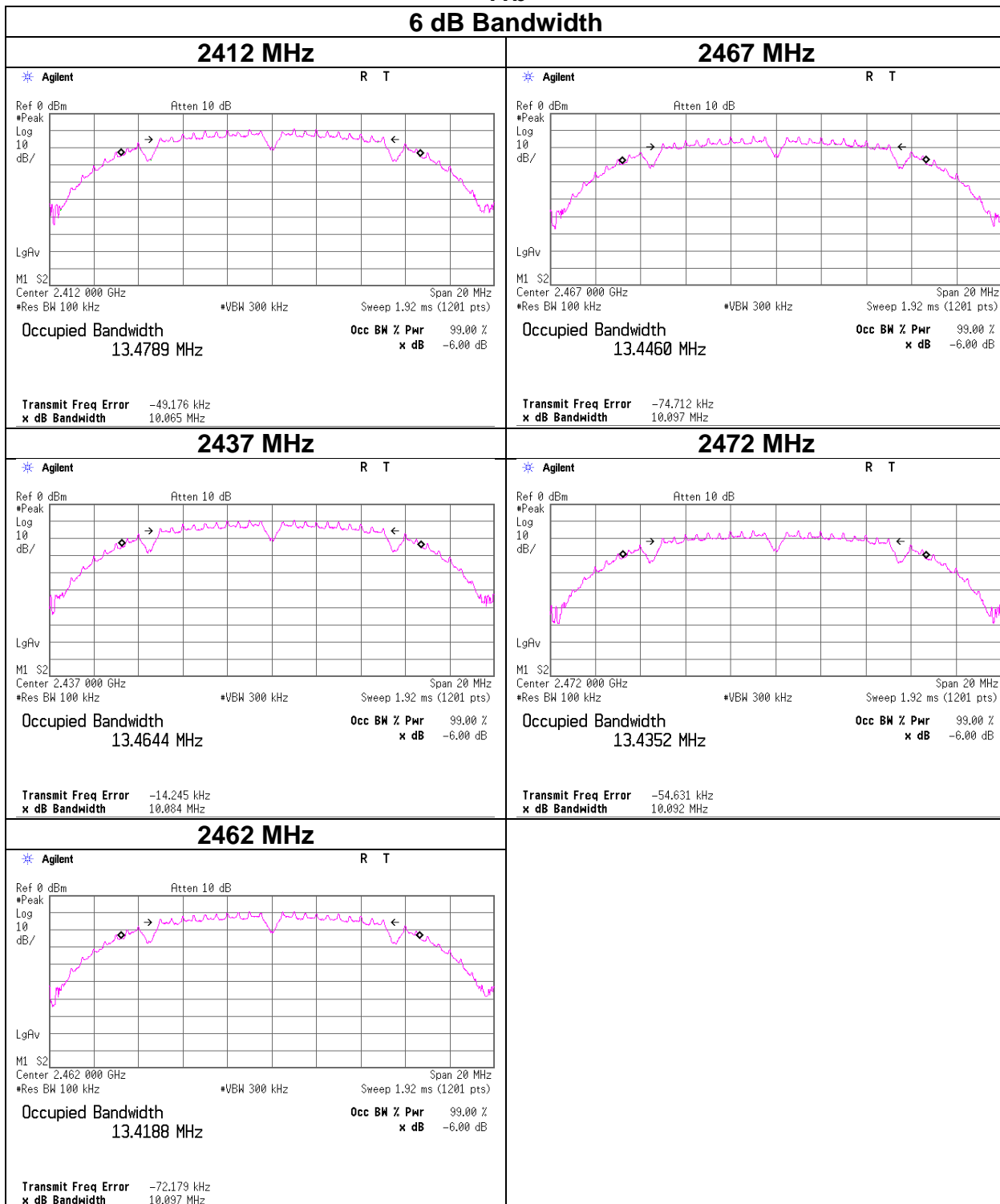
**99 % Occupied Bandwidth**



**99 % Occupied Bandwidth and 6 dB Bandwidth**

11b

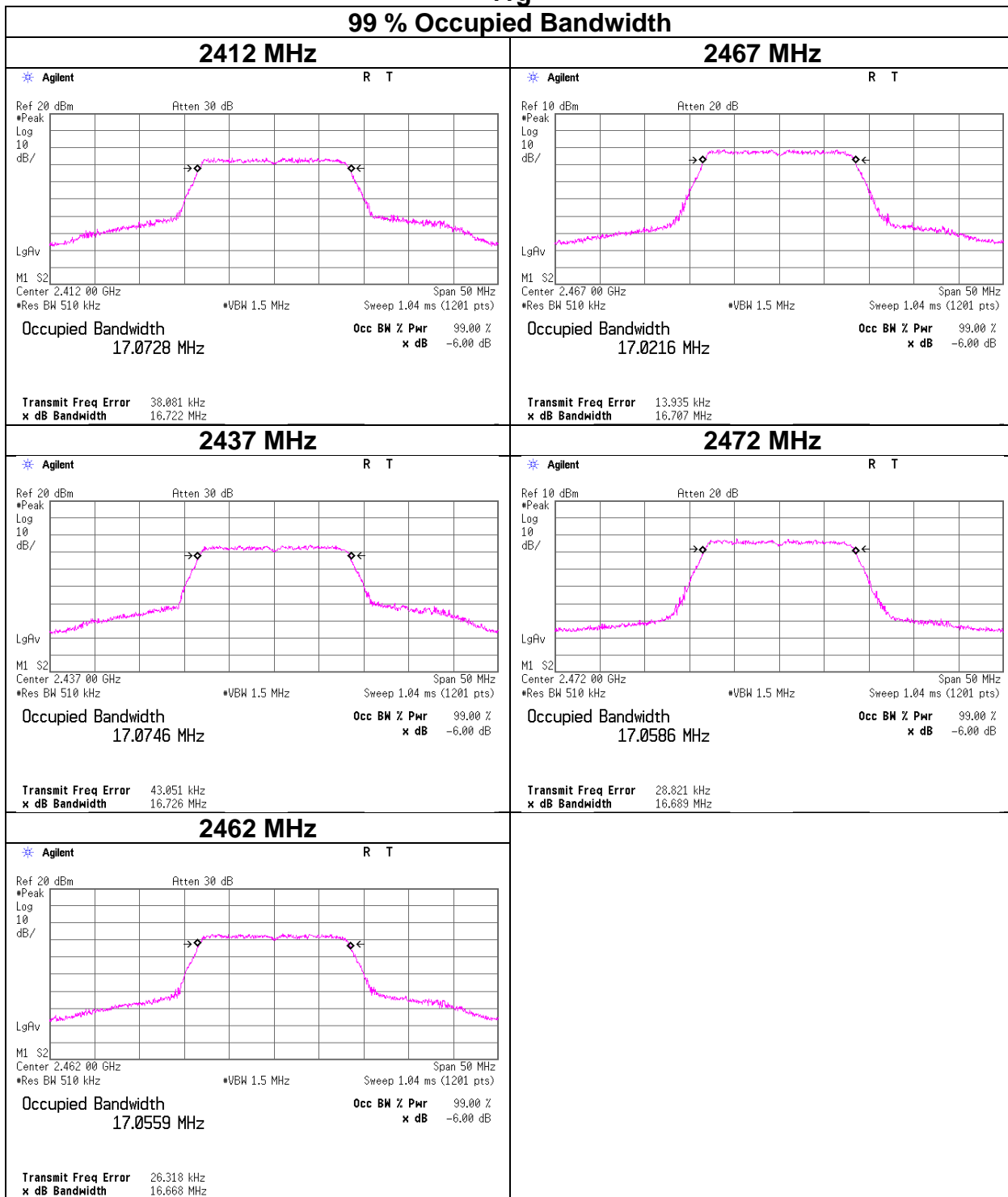
**6 dB Bandwidth**



**99 % Occupied Bandwidth and 6 dB Bandwidth**

11g

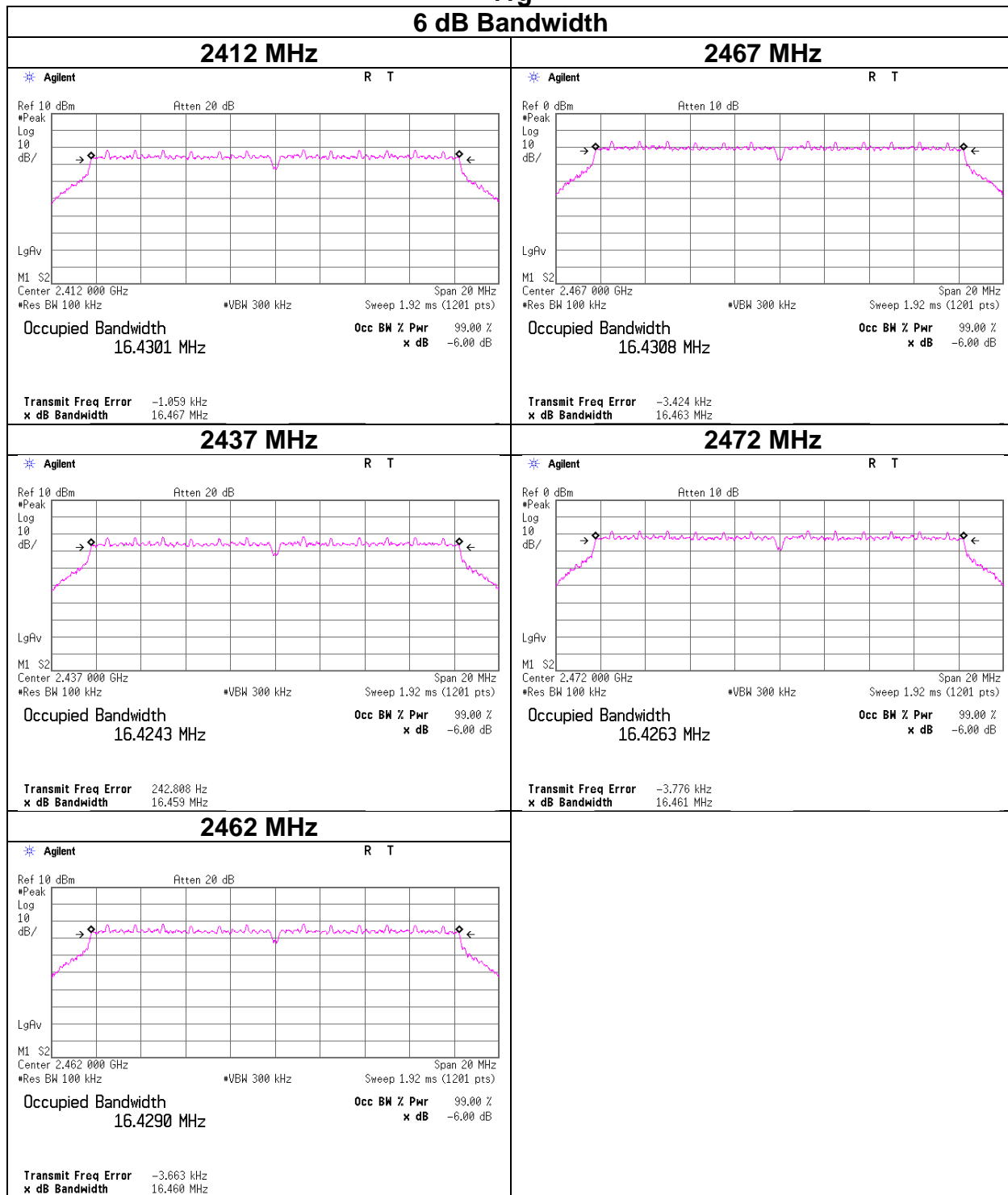
**99 % Occupied Bandwidth**



**99 % Occupied Bandwidth and 6 dB Bandwidth**

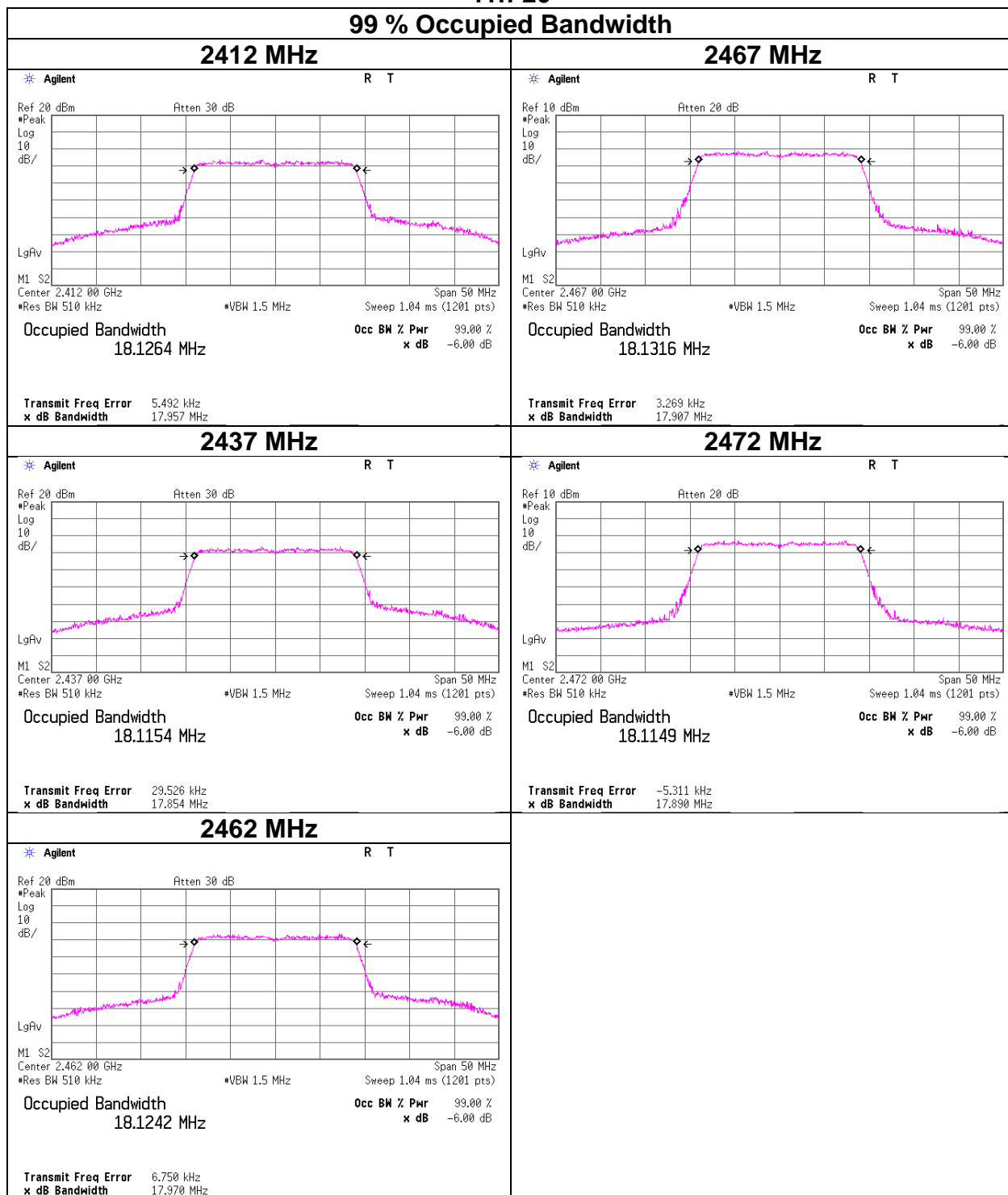
11g

**6 dB Bandwidth**



**99 % Occupied Bandwidth and 6 dB Bandwidth**

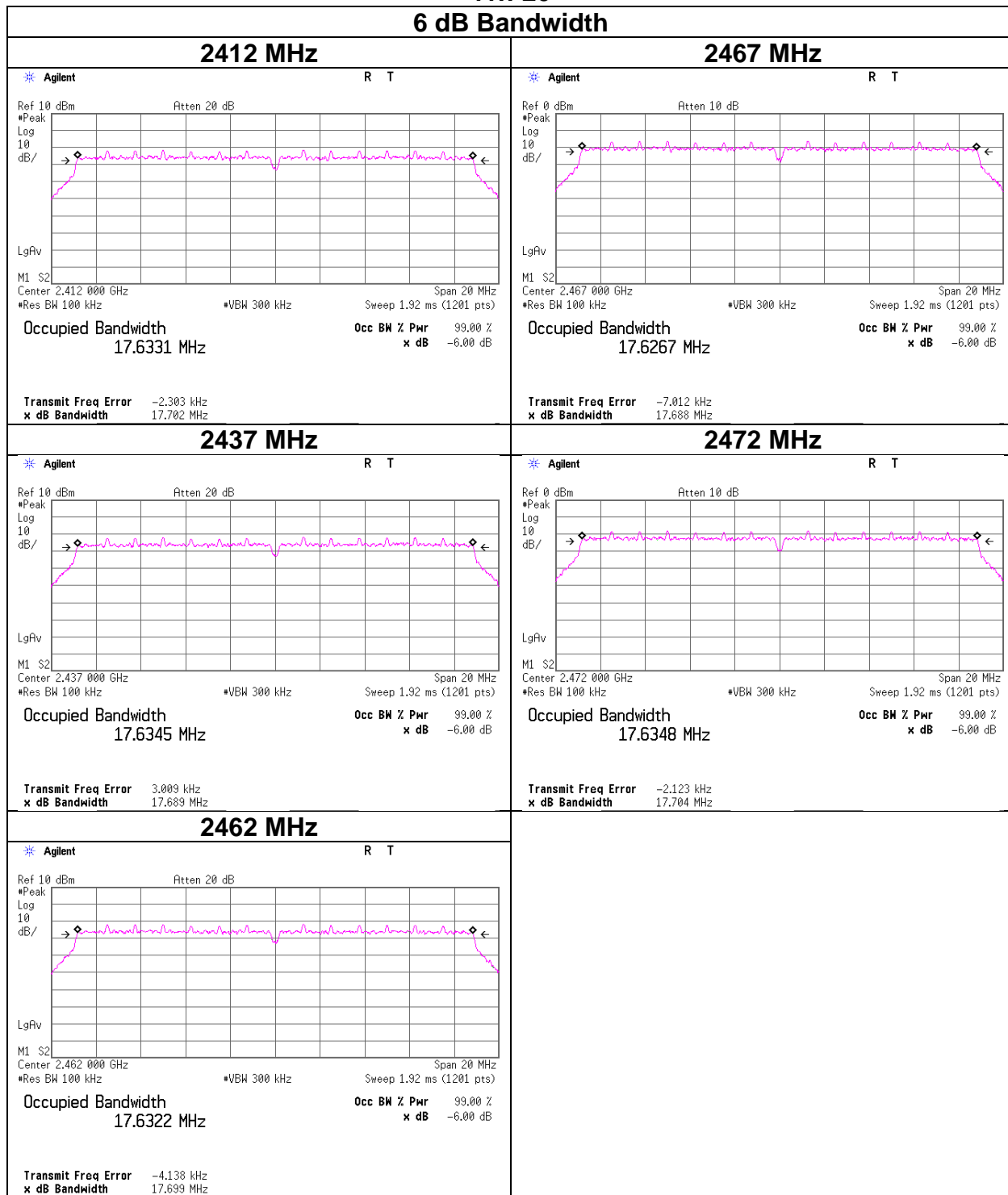
11n-20



**99 % Occupied Bandwidth and 6 dB Bandwidth**

11n-20

**6 dB Bandwidth**





### Maximum Peak Output Power

Test place                    Ise EMC Lab. No.1 Measurement Room  
Date                            March 4, 2024  
Temperature / Humidity    22 deg. C / 38 % RH  
Engineer                     Junya Okuno  
Mode                          Tx 11b

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
				Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
2412	-7.60	1.47	20.00	<b>13.87</b>	<b>24.38</b>	30.00	1000	16.13	3.85	<b>17.72</b>	<b>59.16</b>	36.02	4000	18.30
2437	-7.96	1.48	20.00	13.52	22.49	30.00	1000	16.48	3.85	17.37	54.58	36.02	4000	18.65
2462	-8.03	1.48	20.00	13.45	22.13	30.00	1000	16.55	3.85	17.30	53.70	36.02	4000	18.72
2467	-1.89	1.48	9.98	9.57	9.06	30.00	1000	20.43	3.85	13.42	21.98	36.02	4000	22.60
2472	-4.19	1.48	9.98	7.27	5.33	30.00	1000	22.73	3.85	11.12	12.94	36.02	4000	24.90

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

\*The equipment and cables were not used for factor 0 dB of the data sheets.

2437 MHz

Rate	Reading	Remark
[Mbps]	[dBm]	
1	-7.96	*
2	-7.99	
5.5	-8.20	
11	-8.24	

\*: Worst Rate

### Maximum Peak Output Power

Test place                    Ise EMC Lab. No.1 Measurement Room  
Date                            March 4, 2024  
Temperature / Humidity    22 deg. C / 38 % RH  
Engineer                     Junya Okuno  
Mode                          Tx 11g

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
				Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
2412	0.30	1.47	20.00	<b>21.77</b>	<b>150.31</b>	30.00	1000	8.23	3.85	<b>25.62</b>	<b>364.75</b>	36.02	4000	10.40
2437	-0.22	1.48	20.00	21.26	133.66	30.00	1000	8.74	3.85	25.11	324.34	36.02	4000	10.91
2462	-0.32	1.48	20.00	21.16	130.62	30.00	1000	8.84	3.85	25.01	316.96	36.02	4000	11.01
2467	5.73	1.48	9.98	17.19	52.36	30.00	1000	12.81	3.85	21.04	127.06	36.02	4000	14.98
2472	4.00	1.48	9.98	15.46	35.16	30.00	1000	14.54	3.85	19.31	85.31	36.02	4000	16.71

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

\*The equipment and cables were not used for factor 0 dB of the data sheets.

2437 MHz

Rate	Reading	Remark
[Mbps]	[dBm]	
6	-1.49	
9	-1.41	
12	-1.35	
18	-0.22	*
24	-1.05	
36	-0.66	
48	-1.22	
54	-0.97	

\*: Worst Rate

## Maximum Peak Output Power

Test place	Ise EMC Lab. No.1 Measurement Room
Date	March 4, 2024
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Junya Okuno
Mode	Tx 11n-20

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
				Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
2412	0.32	1.47	20.00	<b>21.79</b>	<b>151.01</b>	30.00	1000	8.21	3.85	<b>25.64</b>	<b>366.44</b>	36.02	4000	10.38
2437	-0.05	1.48	20.00	21.43	139.00	30.00	1000	8.57	3.85	25.28	337.29	36.02	4000	10.74
2462	-0.20	1.48	20.00	21.28	134.28	30.00	1000	8.72	3.85	25.13	325.84	36.02	4000	10.89
2467	5.85	1.48	9.98	17.31	53.83	30.00	1000	12.69	3.85	21.16	130.62	36.02	4000	14.86
2472	4.07	1.48	9.98	15.53	35.73	30.00	1000	14.47	3.85	19.38	86.70	36.02	4000	16.64

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

\*The equipment and cables were not used for factor 0 dB of the data sheets.

2437 MHz

MCS Number	Reading Long GI [dBm]	Reading Short GI [dBm]	Remark
0	-0.72	-	
1	-0.05	-0.28	*Long GI
2	-1.22	-	
3	-0.93	-	
4	-0.61	-	
5	-1.18	-	
6	-0.88	-	
7	-1.20	-	

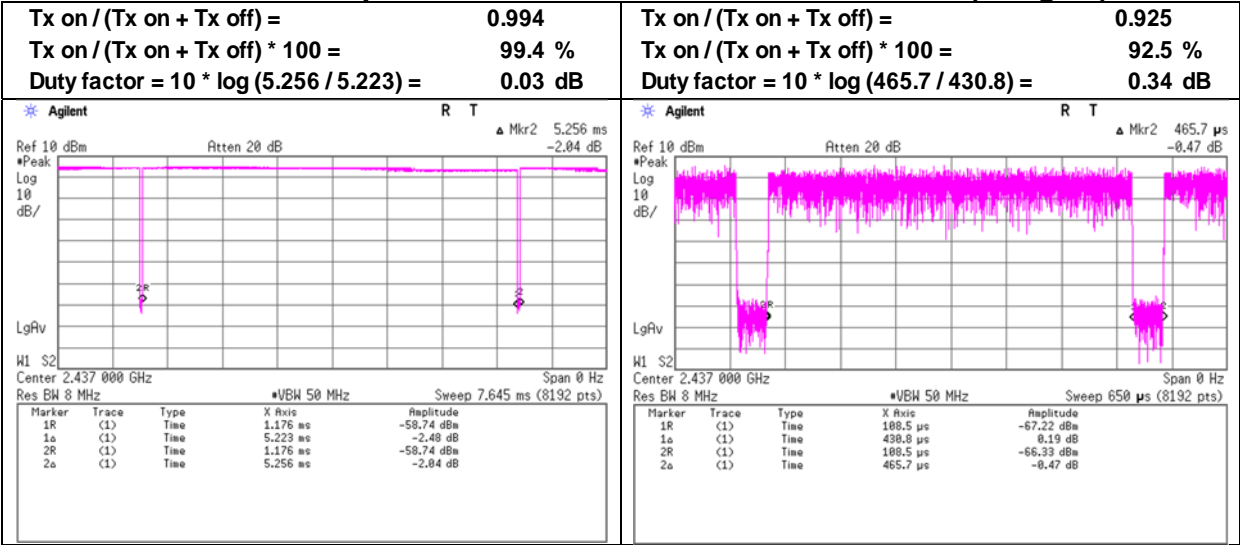
\*: Worst MCS

**Burst rate confirmation**

Test place                    Ise EMC Lab. No.1 Measurement Room  
 Date                            March 4, 2024  
 Temperature / Humidity    22 deg. C / 38 % RH  
 Engineer                      Junya Okuno  
 Mode                            Tx

**11b 1 Mbps**

**11n-20 MCS 1 (Long GI)**



\* Since the burst rate is not different between the channels, the data has been obtained on the representative channel.

## Radiated Spurious Emission

Test place	Ise EMC Lab.	No.4
Semi Anechoic Chamber	No.1	March 5, 2024
Date	March 4, 2024	20 deg. C / 39 % RH
Temperature / Humidity	20 deg. C / 35 % RH	Yuichiro Yamazaki
Engineer	Yuichiro Yamazaki	(6 GHz to 10 GHz)
	(1 GHz to 6 GHz,	
	Above 10 GHz)	
Mode	Tx 11b 2412 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2390.0	57.3	40.9	27.7	5.7	36.0	-	54.6	38.3	73.9	53.9	19.3	15.6	
Hori.	4824.0	43.4	35.5	31.5	7.9	35.6	-	47.3	39.4	73.9	53.9	26.6	14.5	Floor noise
Hori.	7236.0	42.4	32.2	35.7	9.5	32.1	-	55.5	45.3	73.9	53.9	18.4	8.6	Floor noise
Hori.	9648.0	43.9	33.5	35.8	10.3	32.3	-	57.7	47.3	73.9	53.9	16.2	6.6	Floor noise
Vert.	2390.0	58.3	41.6	27.7	5.7	36.0	-	55.6	38.9	73.9	53.9	18.3	15.0	
Vert.	4824.0	44.0	35.5	31.5	7.9	35.6	-	47.8	39.4	73.9	53.9	26.1	14.5	Floor noise
Vert.	7236.0	42.5	32.3	35.7	9.5	32.1	-	55.6	45.4	73.9	53.9	18.3	8.5	Floor noise
Vert.	9648.0	43.7	33.7	35.8	10.3	32.3	-	57.4	47.5	73.9	53.9	16.5	6.4	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)  
 Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor  
 \*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).  
 \*QP detector was used up to 1GHz.

### 20dBc Data Sheet

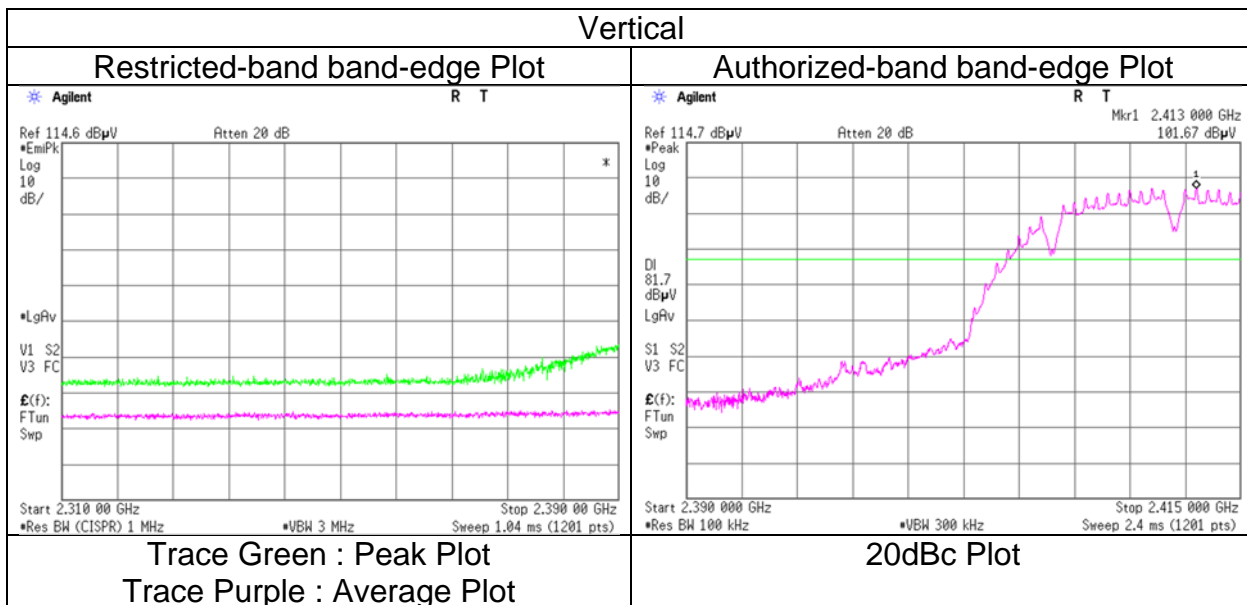
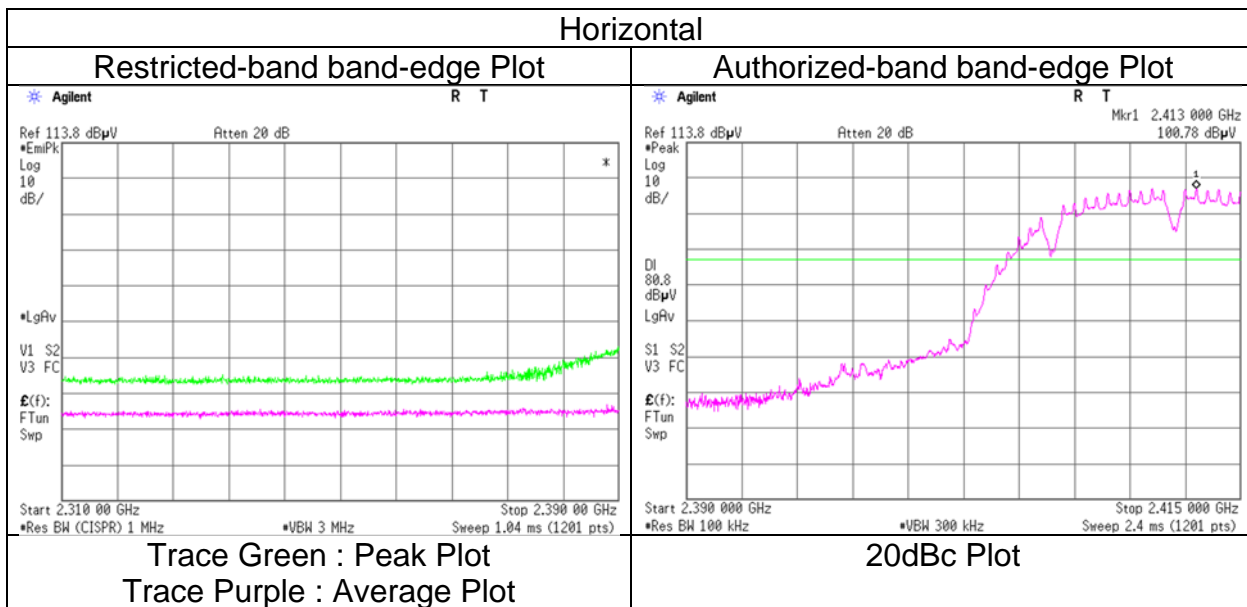
Polarity	Frequency	Reading (PK)	Ant Factor	Loss	Gain	Result	Limit	Margin	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2412.0	100.8	27.7	5.7	36.0	98.1	-	-	Carrier
Hori.	2400.0	53.1	27.7	5.7	36.0	50.4	78.1	27.7	
Vert.	2412.0	101.7	27.7	5.7	36.0	99.0	-	-	Carrier
Vert.	2400.0	54.8	27.7	5.7	36.0	52.2	79.0	26.9	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Distance factor:	1 GHz to 6 GHz	20log(3.95 m / 3.00 m) = 2.4 dB
	6 GHz to 10 GHz	20log(4.95 m / 3.00 m) = 4.4 dB
	10 GHz to 26.5 GHz	20log(1.00 m / 3.00 m) = -9.5 dB

## Radiated Spurious Emission (Reference Plot for band-edge)

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.1
Date	March 4, 2024
Temperature / Humidity	20 deg. C / 35 % RH
Engineer	Yuichiro Yamazaki
	(1 GHz to 6 GHz)
Mode	Tx 11b 2412 MHz



\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
Final result of restricted band edge and authorized band edge were shown in tabular data.

## Radiated Spurious Emission

Test place	Ise EMC Lab.	No.4
Semi Anechoic Chamber	No.1	March 5, 2024
Date	March 4, 2024	20 deg. C / 39 % RH
Temperature / Humidity	20 deg. C / 35 % RH	Yuichiro Yamazaki
Engineer	Yuichiro Yamazaki	(6 GHz to 10 GHz)
	(1 GHz to 6 GHz, Above 10 GHz)	
Mode	Tx 11b 2437 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	4874.0	43.6	35.5	31.6	7.9	35.6	-	47.5	39.5	73.9	53.9	26.4	14.5	Floor noise
Hori.	7311.0	43.4	32.9	35.6	9.5	32.1	-	56.5	46.0	73.9	53.9	17.4	7.9	Floor noise
Hori.	9748.0	43.9	33.6	36.0	10.4	32.4	-	57.9	47.6	73.9	53.9	16.0	6.3	Floor noise
Vert.	4874.0	43.4	35.4	31.6	7.9	35.6	-	47.3	39.3	73.9	53.9	26.6	14.6	Floor noise
Vert.	7311.0	43.3	33.0	35.6	9.5	32.1	-	56.4	46.1	73.9	53.9	17.5	7.8	Floor noise
Vert.	9748.0	43.9	33.5	36.0	10.4	32.4	-	57.9	47.5	73.9	53.9	16.0	6.4	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

\*QP detector was used up to 1GHz.

Distance factor:	1 GHz to 6 GHz	20log(3.95 m / 3.00 m) = 2.4 dB
	6 GHz to 10 GHz	20log(4.95 m / 3.00 m) = 4.4 dB
	10 GHz to 26.5 GHz	20log(1.00 m / 3.00 m) = -9.5 dB

## Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.4
Date	March 4, 2024	March 5, 2024
Temperature / Humidity	20 deg. C / 35 % RH	20 deg. C / 39 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki
	(1 GHz to 6 GHz, Above 10 GHz)	(6 GHz to 10 GHz)
Mode	Tx 11b 2462 MHz	

Polarity	Frequency	Reading	Reading	Ant.	Loss	Gain	Duty	Result	Result	Limit	Limit	Margin	Margin	Remark
[Hori/Vert]	[MHz]	(QP / PK)	(AV)	Factor	[dB]	[dB]	Factor	(QP / PK)	(AV)	(QP / PK)	(AV)	(QP / PK)	(AV)	
		[dBuV]	[dBuV]	[dB/m]			[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2483.5	57.5	41.0	27.6	5.7	36.0	-	54.8	38.3	73.9	53.9	19.1	15.6	
Hori.	4924.0	43.4	35.4	31.7	7.9	35.6	-	47.4	39.4	73.9	53.9	26.5	14.5	Floor noise
Hori.	7386.0	42.6	32.1	35.6	9.6	32.1	-	55.6	45.0	73.9	53.9	18.3	8.9	Floor noise
Hori.	9848.0	43.9	33.7	36.2	10.4	32.4	-	58.0	47.8	73.9	53.9	15.9	6.1	Floor noise
Vert.	2483.5	59.1	42.6	27.6	5.7	36.0	-	56.4	39.9	73.9	53.9	17.5	14.0	
Vert.	4924.0	43.1	35.4	31.7	7.9	35.6	-	47.1	39.4	73.9	53.9	26.8	14.6	Floor noise
Vert.	7386.0	42.9	32.2	35.6	9.6	32.1	-	55.9	45.2	73.9	53.9	18.0	8.8	Floor noise
Vert.	9848.0	43.6	33.7	36.2	10.4	32.4	-	57.7	47.9	73.9	53.9	16.2	6.0	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

\*QP detector was used up to 1GHz.

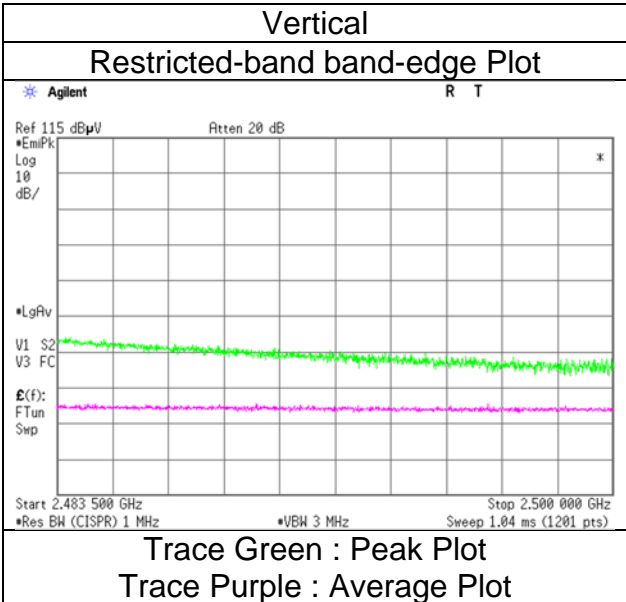
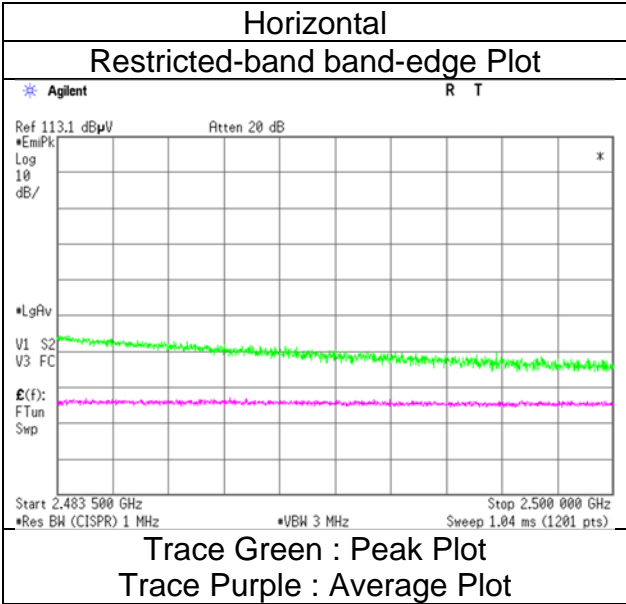
Distance factor:	1 GHz to 6 GHz	20log(3.95 m / 3.00 m) = 2.4 dB
	6 GHz to 10 GHz	20log(4.95 m / 3.00 m) = 4.4 dB
	10 GHz to 26.5 GHz	20log(1.00 m / 3.00 m) = -9.5 dB



**Radiated Spurious Emission  
 (Reference Plot for band-edge)**

Test place  
 Semi Anechoic Chamber  
 Date  
 Temperature / Humidity  
 Engineer  
 Mode

Ise EMC Lab.  
 No.1  
 March 4, 2024  
 20 deg. C / 35 % RH  
 Yuichiro Yamazaki  
 (1 GHz to 6 GHz)  
 Tx 11b 2462 MHz



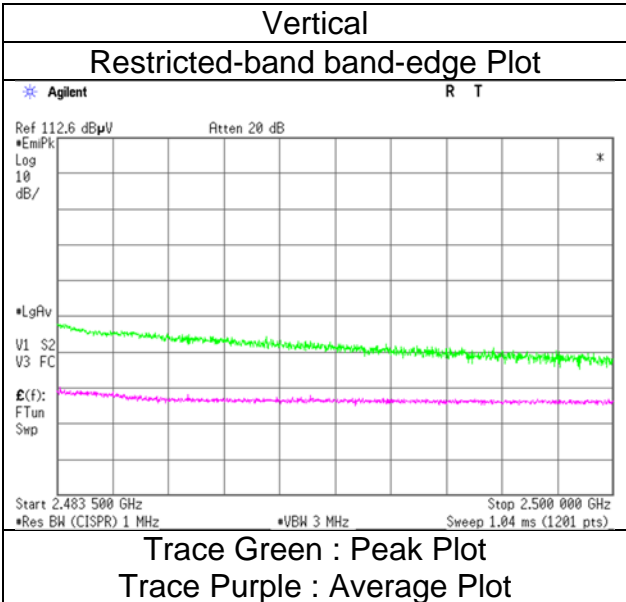
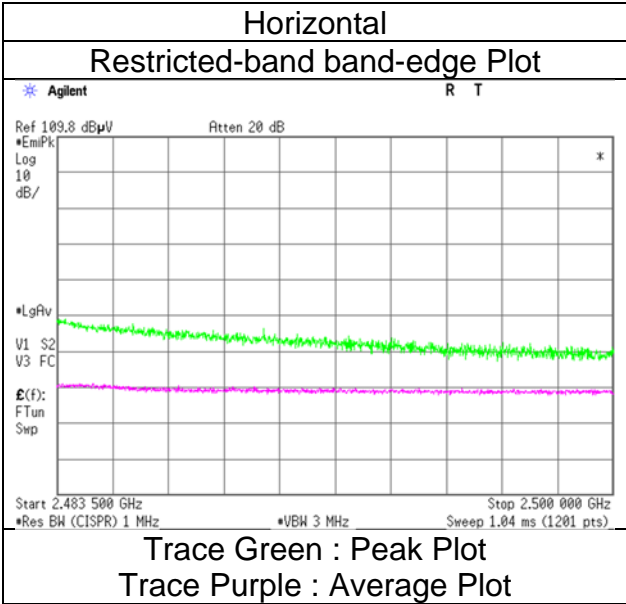
\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
 Final result of restricted band edge was shown in tabular data.



**Radiated Spurious Emission  
 (Reference Plot for band-edge)**

Test place  
 Semi Anechoic Chamber  
 Date  
 Temperature / Humidity  
 Engineer  
 Mode

Ise EMC Lab.  
 No.1  
 March 4, 2024  
 20 deg. C / 35 % RH  
 Yuichiro Yamazaki  
 (1 GHz to 6 GHz)  
 Tx 11b 2467 MHz



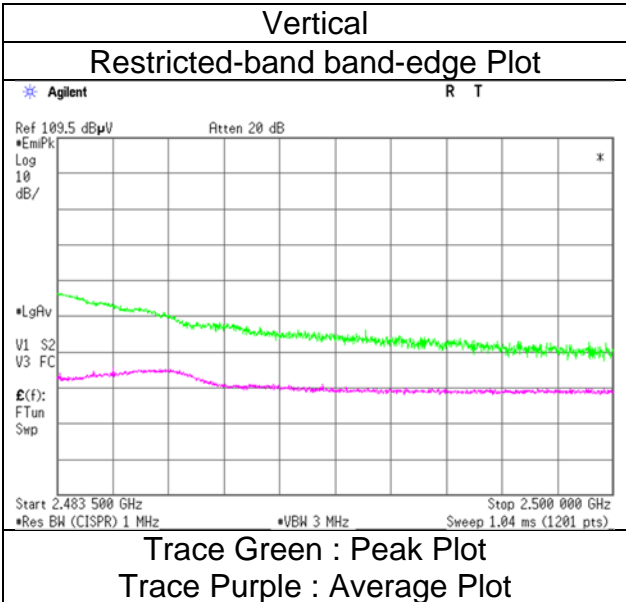
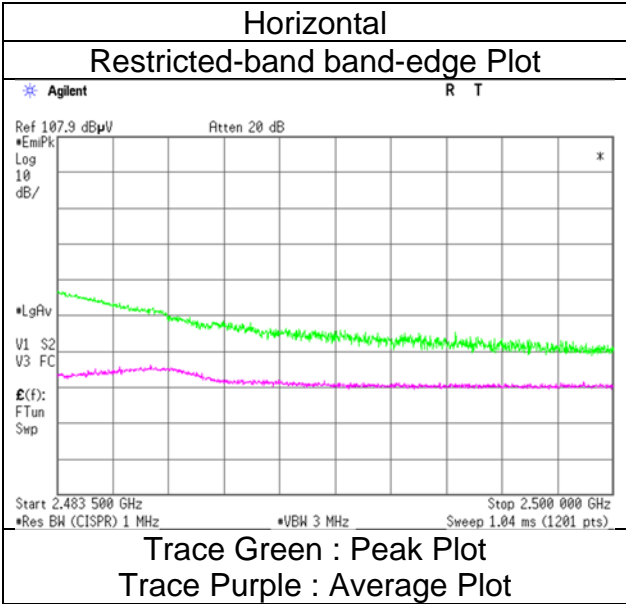
\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
 Final result of restricted band edge was shown in tabular data.



### Radiated Spurious Emission (Reference Plot for band-edge)

Test place  
Semi Anechoic Chamber  
Date  
Temperature / Humidity  
Engineer  
  
Mode

Ise EMC Lab.  
No.1  
March 4, 2024  
20 deg. C / 35 % RH  
Yuichiro Yamazaki  
(1 GHz to 6 GHz)  
Tx 11b 2472 MHz

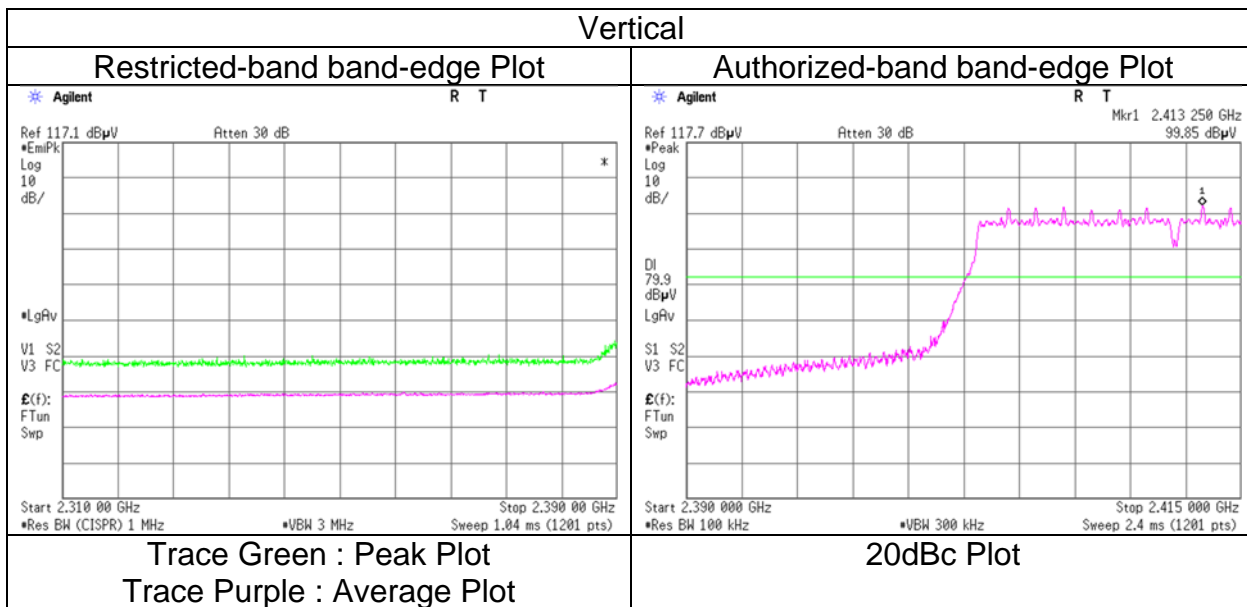
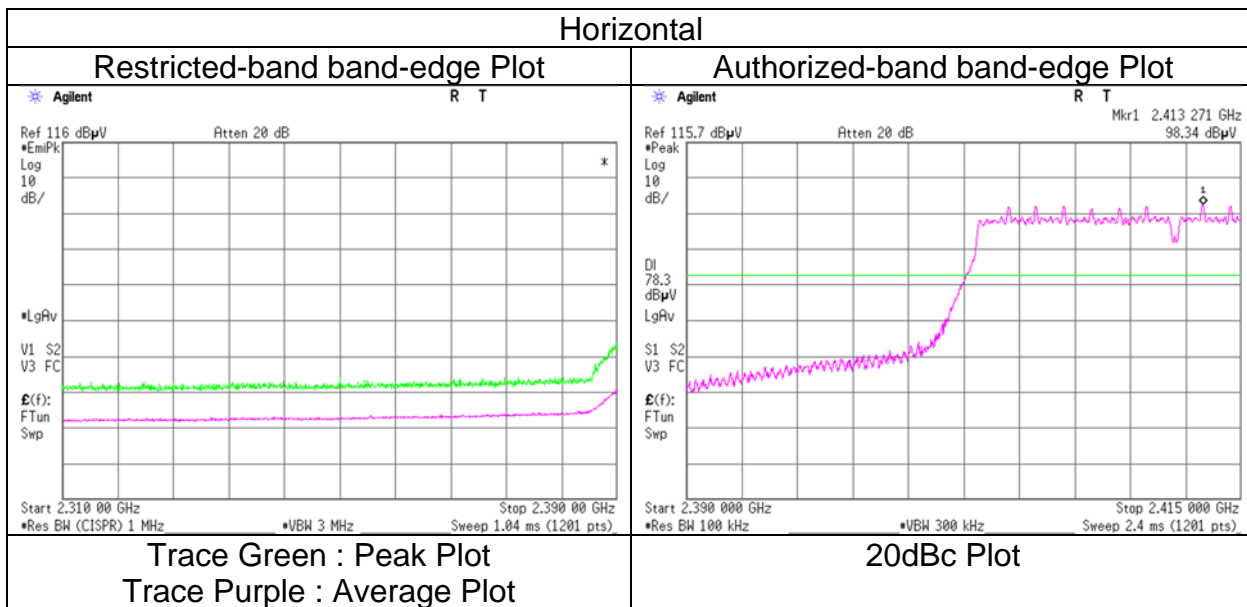


\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
Final result of restricted band edge was shown in tabular data.



## Radiated Spurious Emission (Reference Plot for band-edge)

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.1
Date	March 4, 2024
Temperature / Humidity	20 deg. C / 35 % RH
Engineer	Yuichiro Yamazaki
	(1 GHz to 6 GHz)
Mode	Tx 11n-20 2412 MHz



\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
Final result of restricted band edge and authorized band edge were shown in tabular data.

## Radiated Spurious Emission

Test place	Ise EMC Lab.	No.4
Semi Anechoic Chamber	No.1	No.4
Date	March 4, 2024	March 5, 2024
Temperature / Humidity	20 deg. C / 35 % RH	20 deg. C / 39 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki
	(1 GHz to 6 GHz,	(6 GHz to 10 GHz)
	Above 10 GHz)	
Mode	Tx 11n-20 2437 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	4874.0	43.6	35.3	31.6	7.9	35.6	-	47.5	39.3	73.9	53.9	26.4	14.7	Floor noise
Hori.	7311.0	43.4	33.3	35.6	9.5	32.1	-	56.5	46.4	73.9	53.9	17.4	7.5	Floor noise
Hori.	9748.0	43.9	33.7	36.0	10.4	32.4	-	57.9	47.6	73.9	53.9	16.0	6.3	Floor noise
Vert.	4874.0	43.9	35.4	31.6	7.9	35.6	-	47.8	39.3	73.9	53.9	26.1	14.6	Floor noise
Vert.	7311.0	43.7	33.5	35.6	9.5	32.1	-	56.7	46.5	73.9	53.9	17.2	7.4	Floor noise
Vert.	9748.0	43.9	33.4	36.0	10.4	32.4	-	57.9	47.4	73.9	53.9	16.0	6.5	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

\*QP detector was used up to 1GHz.

Distance factor:	1 GHz to 6 GHz	20log(3.95 m / 3.00 m) = 2.4 dB
	6 GHz to 10 GHz	20log(4.95 m / 3.00 m) = 4.4 dB
	10 GHz to 26.5 GHz	20log(1.00 m / 3.00 m) = -9.5 dB



## Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.4
Date	March 4, 2024	March 5, 2024
Temperature / Humidity	20 deg. C / 35 % RH	20 deg. C / 39 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki
	(1 GHz to 6 GHz,	(6 GHz to 10 GHz)
	Above 10 GHz)	
Mode	Tx 11n-20 2462 MHz	

Polarity	Frequency	Reading	Reading	Ant.	Loss	Gain	Duty	Result	Result	Limit	Limit	Margin	Margin	Remark
[Hori/Vert]	[MHz]	(QP / PK)	(AV)	Factor	[dB]	[dB]	Factor	(QP / PK)	(AV)	(QP / PK)	(AV)	(QP / PK)	(AV)	
		[dBuV]	[dBuV]	[dB/m]			[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2483.5	66.4	52.3	27.6	5.7	36.0	0.3	63.7	50.0	73.9	53.9	10.2	3.9	*1)
Hori.	4924.0	43.3	35.5	31.7	7.9	35.6	-	47.3	39.5	73.9	53.9	26.6	14.4	Floor noise
Hori.	7386.0	32.8	32.1	35.6	9.6	32.1	-	45.8	45.1	73.9	53.9	28.1	8.8	Floor noise
Hori.	9848.0	44.1	33.6	36.2	10.4	32.4	-	58.2	47.8	73.9	53.9	15.7	6.1	Floor noise
Vert.	2483.5	68.5	54.4	27.6	5.7	36.0	0.3	65.8	52.1	73.9	53.9	8.1	1.8	*1)
Vert.	4924.0	43.6	35.4	31.7	7.9	35.6	-	47.6	39.4	73.9	53.9	26.3	14.5	Floor noise
Vert.	7386.0	43.0	32.1	35.6	9.6	32.1	-	56.0	45.0	73.9	53.9	17.9	8.9	Floor noise
Vert.	9848.0	43.7	33.7	36.2	10.4	32.4	-	57.9	47.8	73.9	53.9	16.0	6.1	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

\*QP detector was used up to 1GHz.

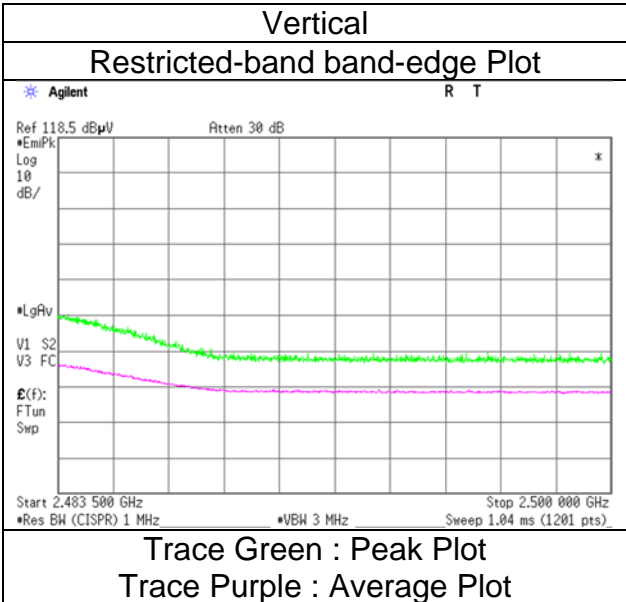
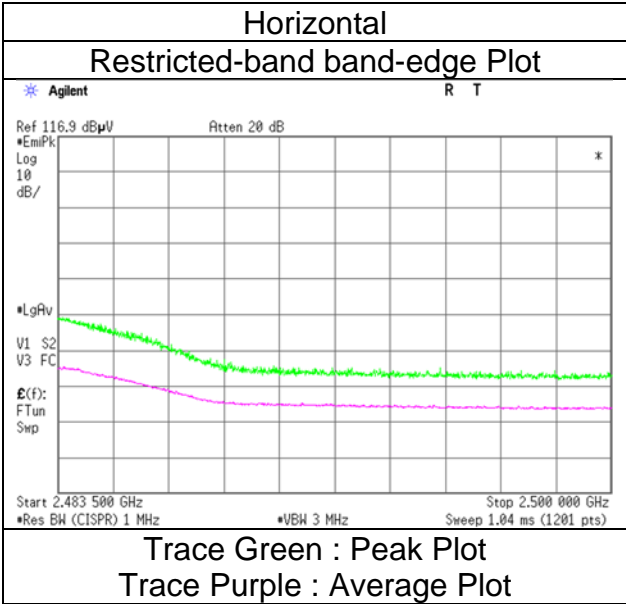
\*1) Not Out of Band emission(Leakage Power)

Distance factor:	1 GHz to 6 GHz	20log(3.95 m / 3.00 m) = 2.4 dB
	6 GHz to 10 GHz	20log(4.95 m / 3.00 m) = 4.4 dB
	10 GHz to 26.5 GHz	20log(1.00 m / 3.00 m) = -9.5 dB

**Radiated Spurious Emission  
 (Reference Plot for band-edge)**

Test place  
 Semi Anechoic Chamber  
 Date  
 Temperature / Humidity  
 Engineer  
 Mode

Ise EMC Lab.  
 No.1  
 March 4, 2024  
 20 deg. C / 35 % RH  
 Yuichiro Yamazaki  
 (1 GHz to 6 GHz)  
 Tx 11n-20 2462 MHz



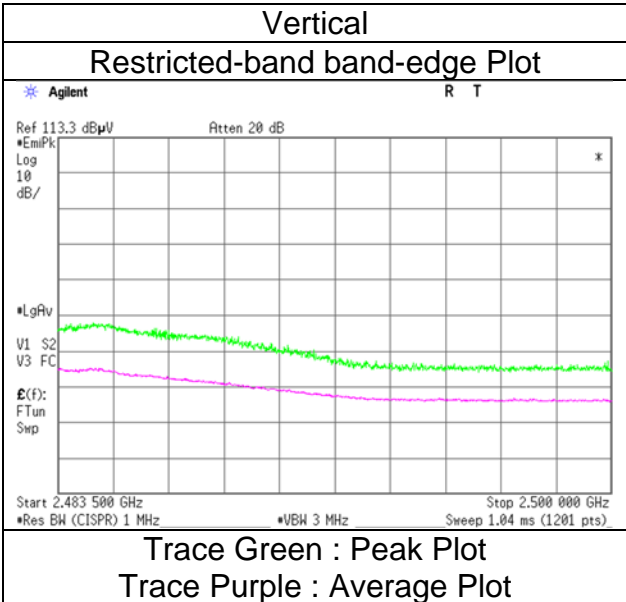
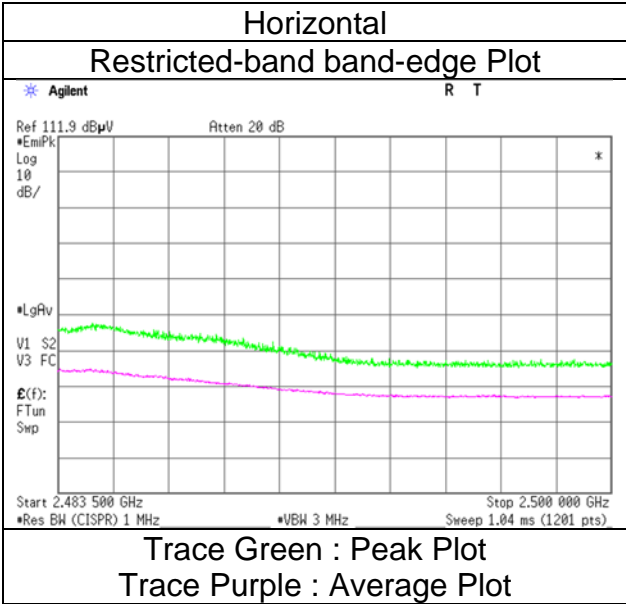
\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
 Final result of restricted band edge was shown in tabular data.



**Radiated Spurious Emission  
 (Reference Plot for band-edge)**

Test place  
 Semi Anechoic Chamber  
 Date  
 Temperature / Humidity  
 Engineer  
 Mode

Ise EMC Lab.  
 No.1  
 March 4, 2024  
 20 deg. C / 35 % RH  
 Yuichiro Yamazaki  
 (1 GHz to 6 GHz)  
 Tx 11n-20 2467 MHz



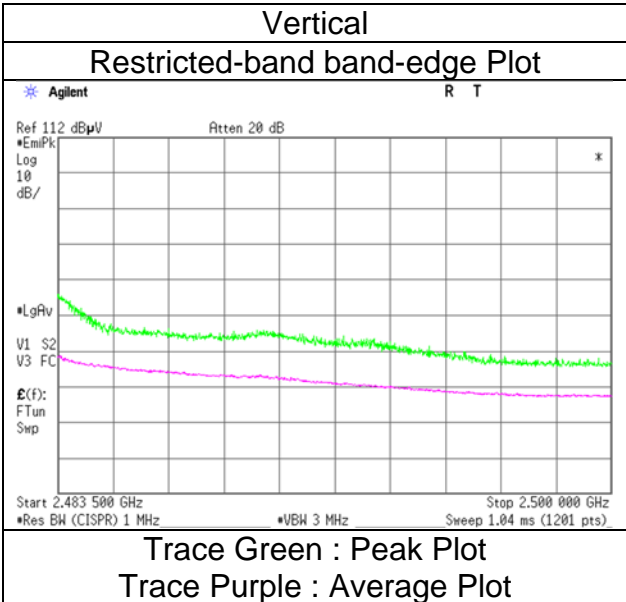
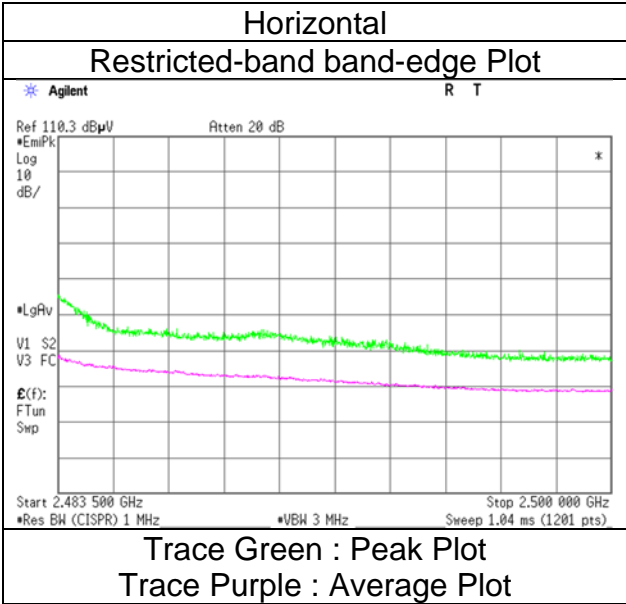
\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
 Final result of restricted band edge was shown in tabular data.



**Radiated Spurious Emission  
 (Reference Plot for band-edge)**

Test place  
 Semi Anechoic Chamber  
 Date  
 Temperature / Humidity  
 Engineer  
 Mode

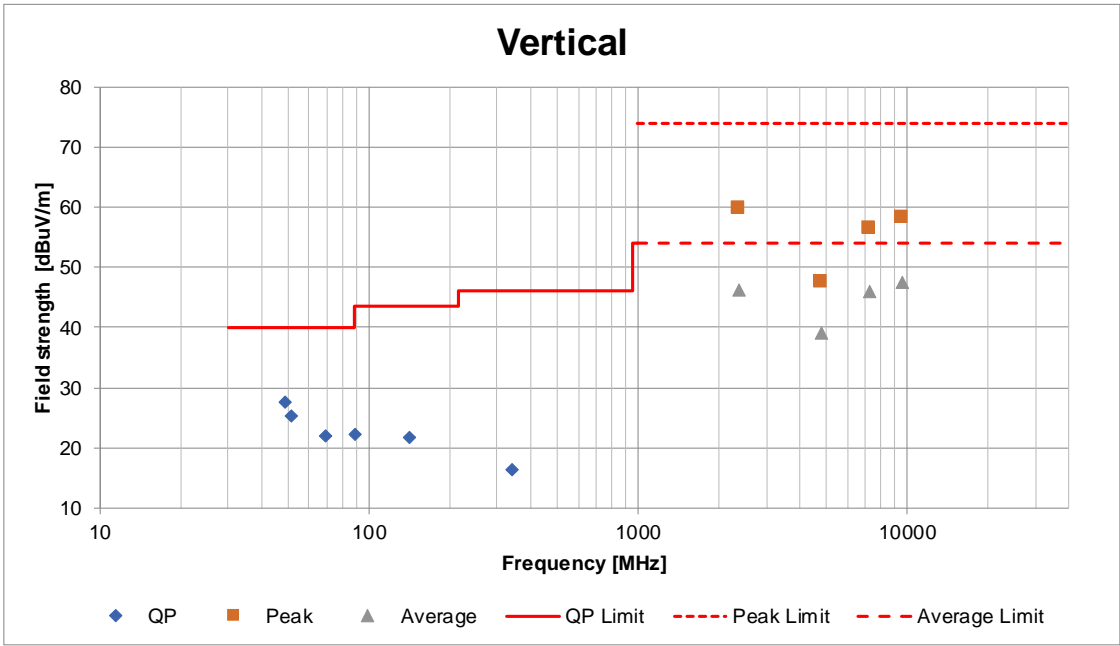
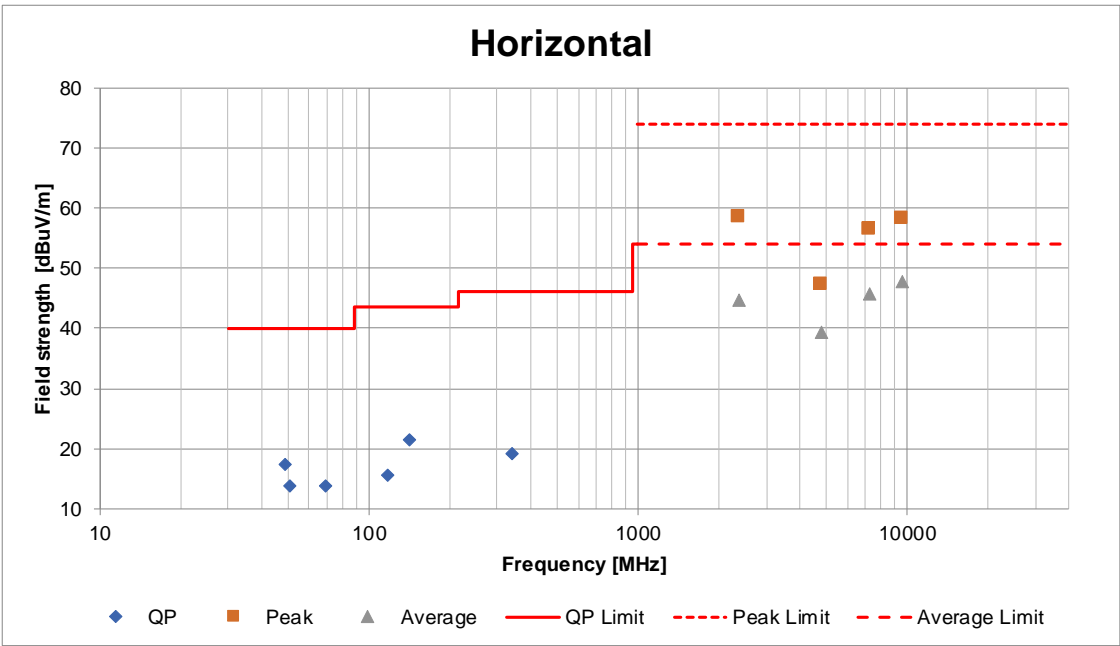
Ise EMC Lab.  
 No.1  
 March 4, 2024  
 20 deg. C / 35 % RH  
 Yuichiro Yamazaki  
 (1 GHz to 6 GHz)  
 Tx 11n-20 2472 MHz



\* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.  
 Final result of restricted band edge was shown in tabular data.

**Radiated Spurious Emission**  
**(Plot data, Worst case mode for Maximum Peak Output Power)**

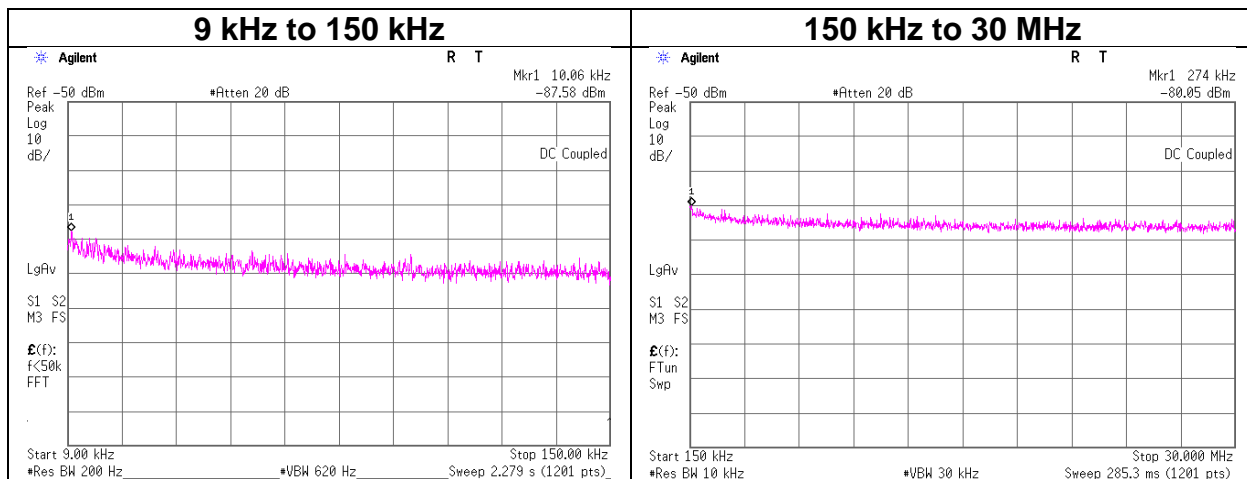
Test place	Ise EMC Lab.	No.4
Semi Anechoic Chamber	No.1	March 5, 2024
Date	March 4, 2024	20 deg. C / 39 % RH
Temperature / Humidity	20 deg. C / 35 % RH	Yuichiro Yamazaki
Engineer	Yuichiro Yamazaki	(6 GHz to 10 GHz, Below 1 GHz)
Mode	(1 GHz to 6 GHz, Above 10 GHz)	
	Tx 11n-20 2412 MHz	



\*These plots data contain sufficient number to show the trend of characteristic features for EUT.

### Conducted Spurious Emission

Test place Ise EMC Lab. No.1 Measurement Room  
 Date March 4, 2024  
 Temperature / Humidity 22 deg. C / 38 % RH  
 Engineer Junya Okuno  
 Mode Tx 11n-20 2412 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
10.06	-87.58	0.40	9.84	3.85	1	-73.49	300	6.00	-12.23	47.50	59.73	
274.00	-80.05	0.41	9.84	3.85	1	-65.95	300	6.00	-4.69	18.80	23.49	

$E \text{ [dBuV/m]} = \text{EIRP [dBm]} - 20 \log (\text{Distance [m]}) + \text{Ground bounce [dB]} + 104.8 \text{ [dBuV/m]}$   
 $\text{EIRP [dBm]} = \text{Reading [dBm]} + \text{Cable loss [dB]} + \text{Attenuator Loss [dB]} + \text{Antenna gain [dBi]} + 10 * \log (N)$   
 N: Number of output



## Power Density

Test place  
Date  
Temperature / Humidity  
Engineer  
Mode

Ise EMC Lab. No.1 Measurement Room  
March 4, 2024  
22 deg. C / 38 % RH  
Junya Okuno  
Tx

11b

Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm / 3 kHz]	[dB]	[dB]	[dBm / 3 kHz]	[dBm / 3 kHz]	[dB]
2412	-23.40	1.47	9.98	<b>-11.95</b>	8.00	19.95
2437	-23.62	1.48	9.98	-12.16	8.00	20.16
2462	-23.84	1.48	9.98	-12.38	8.00	20.38
2467	-27.40	1.48	9.98	-15.94	8.00	23.94
2472	-30.01	1.48	9.98	-18.55	8.00	26.55

11g

Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm / 3 kHz]	[dB]	[dB]	[dBm / 3 kHz]	[dBm / 3 kHz]	[dB]
2412	-25.82	1.47	9.98	-14.37	8.00	22.37
2437	-25.61	1.48	9.98	<b>-14.15</b>	8.00	22.15
2462	-26.22	1.48	9.98	-14.76	8.00	22.76
2467	-31.05	1.48	9.98	-19.59	8.00	27.59
2472	-32.08	1.48	9.98	-20.62	8.00	28.62

11n-20

Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm / 3 kHz]	[dB]	[dB]	[dBm / 3 kHz]	[dBm / 3 kHz]	[dB]
2412	-25.69	1.47	9.98	-14.24	8.00	22.24
2437	-25.63	1.48	9.98	<b>-14.17</b>	8.00	22.17
2462	-25.82	1.48	9.98	-14.36	8.00	22.36
2467	-30.68	1.48	9.98	-19.22	8.00	27.22
2472	-32.41	1.48	9.98	-20.95	8.00	28.95

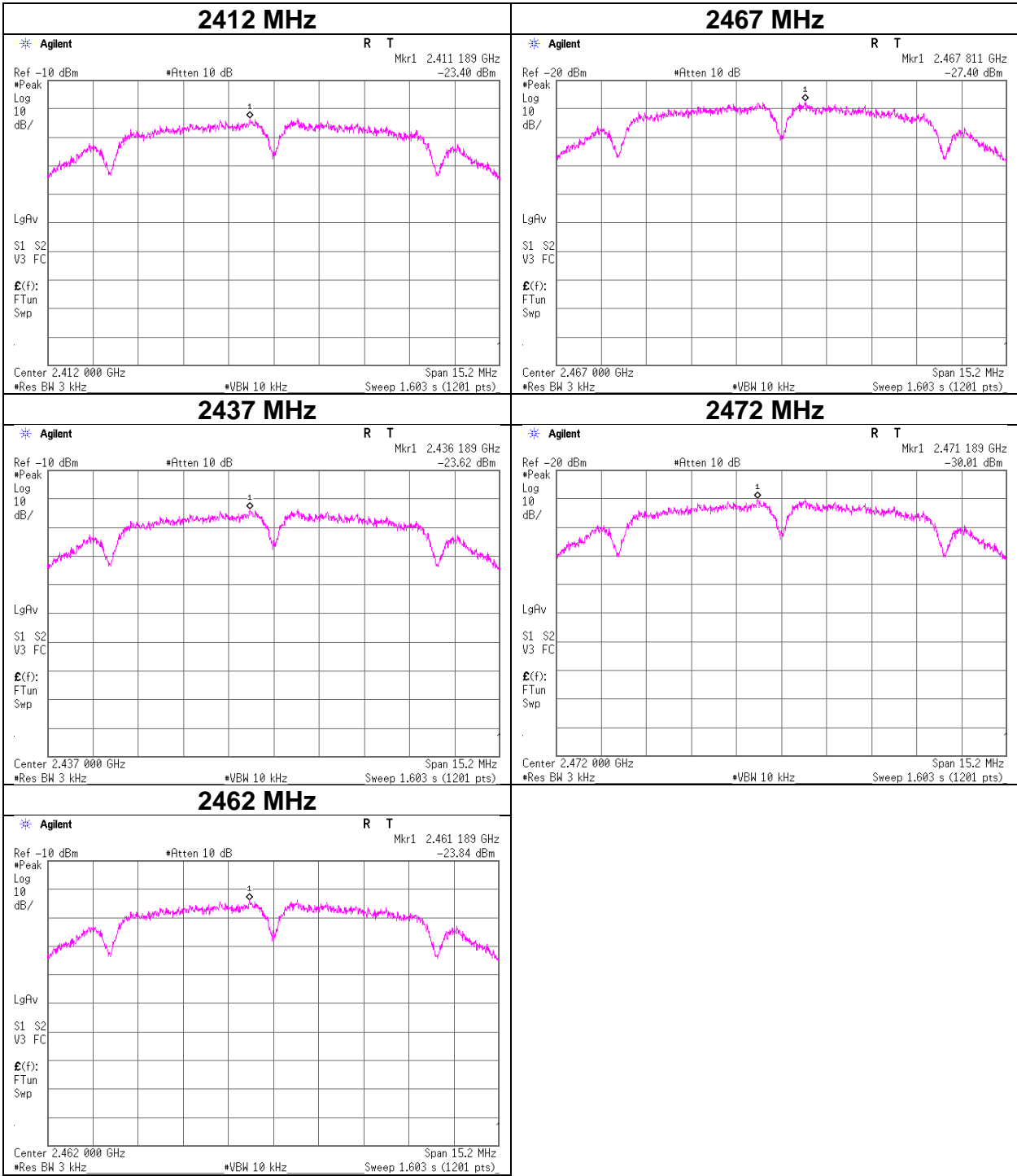
Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

\*The equipment and cables were not used for factor 0 dB of the data sheets.

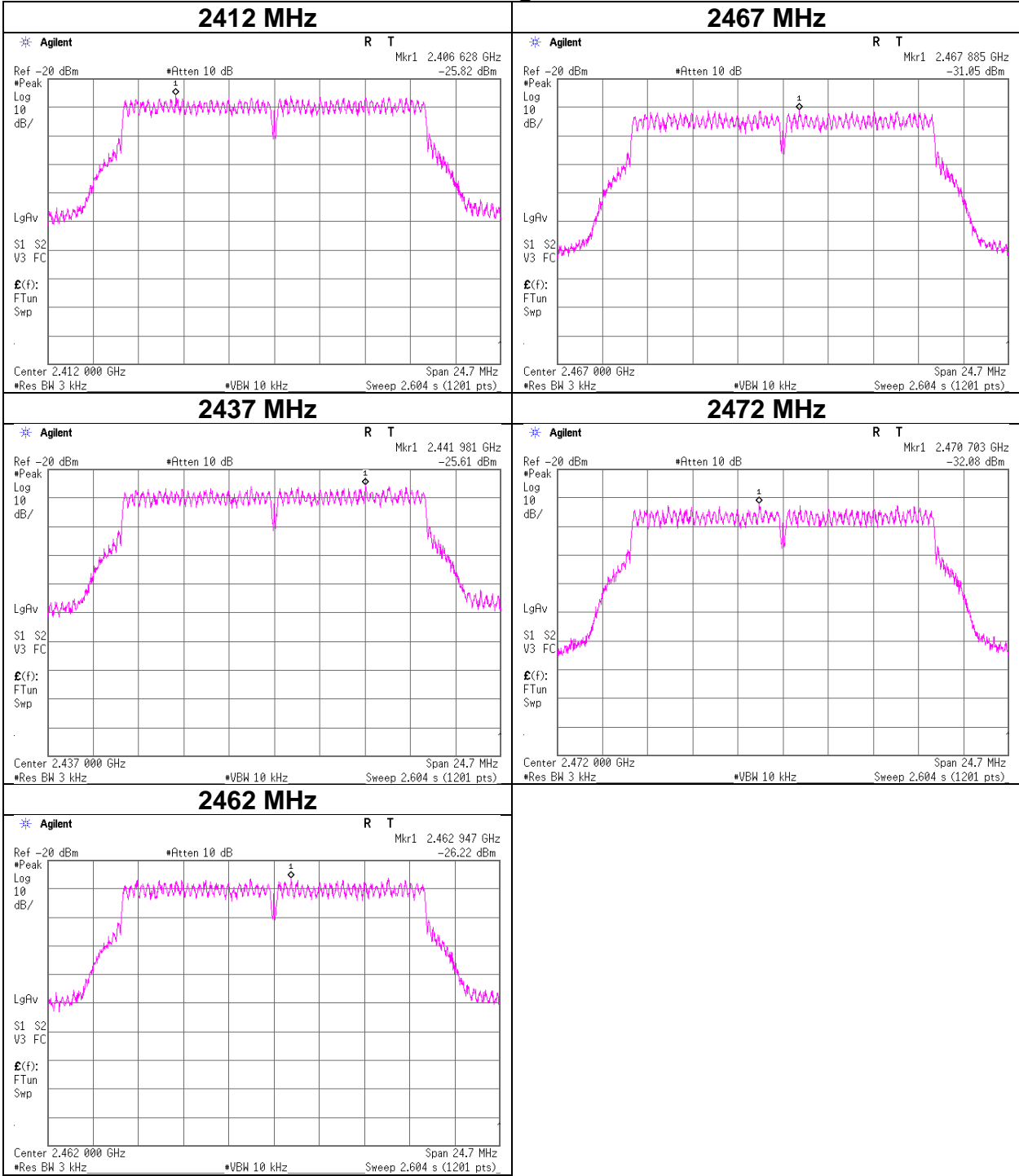
**Power Density**

11b



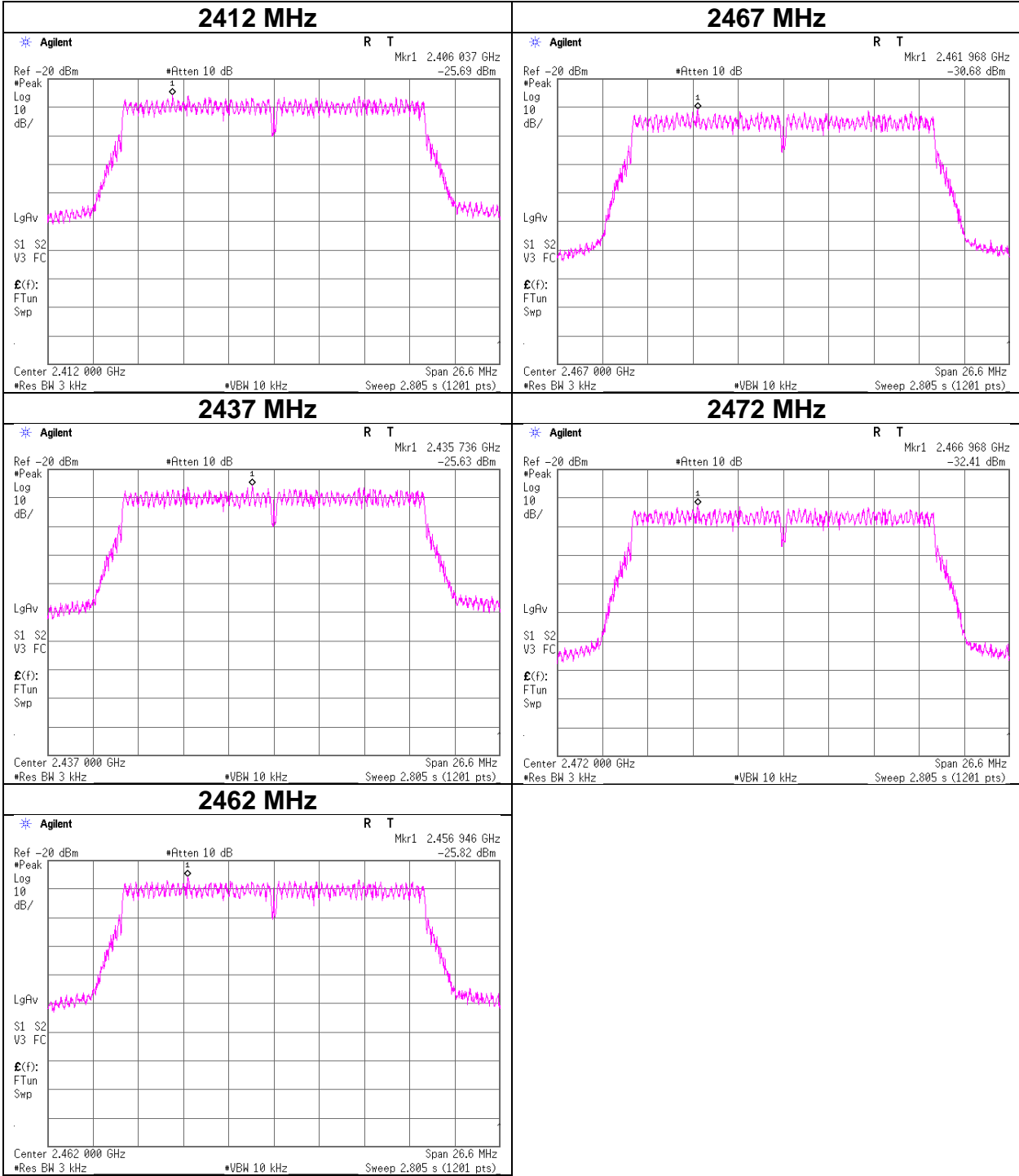
**Power Density**

11g



**Power Density**

11n-20



## APPENDIX 2: Test Instruments

### Test Equipment (1/2)

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
CE	141217	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM141/421-010/sucoform141-PE/RFM-E121(SW)	-/04178	06/27/2023	12
CE	141248	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	12/08/2023	12
CE	141357	LISN(AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-729	07/05/2023	12
CE	141545	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	51201148	02/01/2024	12
CE	141562	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	0010	-	-
CE	141951	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	04/10/2023	12
CE	142230	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
CE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	141267	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-192	09/21/2023	12
RE	141296	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	002	09/01/2023	12
RE	141331	Attenuator(6dB)	TME	UFA-01	-	02/17/2024	12
RE	141393	Microwave Cable	Junkosha	MWX221	1604S254(1 m) / 1608S088(5 m)	08/01/2023	12
RE	141397	Coaxial Cable	UL Japan	-	-	11/22/2023	12
RE	141404	High Pass Filter 3.5-24GHz	TOKIMEC	TF323DCA	601	05/29/2023	12
RE	141425	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103+ BBA9106	VHA 91031302	08/10/2023	12
RE	141506	Horn Antenna 15-40GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9170	BBHA9170307	08/09/2023	12
RE	141511	Horn Antenna 1-18GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9120D	253	09/25/2023	12
RE	141530	Digital Tester	Fluke Corporation	FLUKE 26-3	78030621	02/01/2024	12
RE	141545	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	51201148	02/01/2024	12
RE	141562	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	0010	-	-
RE	141568	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	2901	01/10/2024	12
RE	141576	Pre Amplifier	Keysight Technologies Inc	8449B	3008A01671	02/17/2024	12
RE	141581	MicroWave System Amplifier	Keysight Technologies Inc	83017A	00650	10/05/2023	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	04/05/2023	12
RE	141885	Spectrum Analyzer	Keysight Technologies Inc	E4448A	US44300523	11/29/2023	12
RE	141951	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	04/10/2023	12
RE	141994	AC1_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 10m	DA-06881	09/28/2023	24
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/13/2023	24
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	10/11/2023	12
RE	142226	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
RE	142230	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	238712	Double Ridge Horn Antenna	Schwarzbeck Mess-Elektronik OHG	BBHA 9120 C	687	08/10/2023	12
RE	238713	Double Ridge Horn Antenna	Schwarzbeck Mess-Elektronik OHG	BBHA 9120 C	688	08/10/2023	12

**Test Equipment (2/2)**

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
AT	141156	Attenuator(10dB)	Weinschel Corp	2	BL1173	11/17/2023	12
AT	141174	Attenuator(20dB) (above1GHz)	HIROSE ELECTRIC CO.,LTD.	AT-120	901247	01/15/2024	12
AT	141414	Microwave Cable	Junkosha	MWX221	1207S407	08/01/2023	12
AT	141420	Attenuator	Weinschel Associates	WA56-10	56100307	05/18/2023	12
AT	141530	Digital Tester	Fluke Corporation	FLUKE 26-3	78030621	02/01/2024	12
AT	141568	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	2901	01/10/2024	12
AT	141810	Power Meter	Anritsu Corporation	ML2495A	824014	12/12/2023	12
AT	141832	Power sensor	Anritsu Corporation	MA2411B	738174	12/12/2023	12
AT	141903	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46186390	01/26/2024	12
AT	195231	Microwave Cable	Huber+Suhner	SF102D/11PC24/ 11PC24/1000mm	537062/126E	02/13/2024	12

**\*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.**

**The expiration date of the calibration is the end of the expired month.**

**As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.**

**All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.**

**Test item:**

**CE: Conducted Emission**

**RE: Radiated Emission**

**AT: Antenna Terminal Conducted test**